

SLG59H1020V

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

General Description

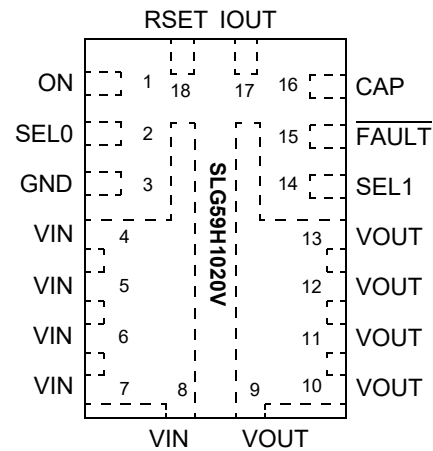
The SLG59H1020V is a high-performance, self-powered 50 mΩ NMOS power switch with back-to-back reverse-current blocking designed for all 4.5 V to 20 V power rails up to 3 A. Using a proprietary MOSFET design, the SLG59H1020V achieves a stable 50 mΩ $R_{DS(ON)}$ across a wide input voltage range. In combining novel FET design and copper pillar interconnects, the SLG59H1020V package also exhibits a low thermal resistance for high-current operation.

Designed to operate over a -40°C to 85°C range, the SLG59H1020V is available in a low thermal resistance, RoHS-compliant, 1.6 x 3.0 mm STQFN package.

Features

- Wide Operating Input Voltage: 4.5 V to 20 V
- Maximum Continuous Current: 3 A
- Back-to-Back FET Reverse Current Blocking, when OFF
- Internal nFET Power Limiting
- High-performance MOSFET Switch
 - Low $R_{DS(ON)}$: 50 mΩ at $V_{IN} = 20\text{ V}$
 - Low $\Delta R_{DS(ON)}/\Delta V_{IN}$: $< 0.05\text{ m}\Omega/\text{V}$
 - Low $\Delta R_{DS(ON)}/\Delta T$: $< 0.06\text{ m}\Omega/^{\circ}\text{C}$
- 4-Level, Pin-selectable V_{IN} Overvoltage Lockout
- Capacitor-adjustable Inrush Current Control
- Two stage Current Limit Protection:
 - Resistor-adjustable Active Current Limit
 - Internal Short-circuit Current limit
- Open Drain $\overline{\text{FAULT}}$ Signaling
- MOSFET Current Analog Output Monitor: 10 $\mu\text{A}/\text{A}$
 - Pb-Free / Halogen-Free / RoHS Compliant Packaging

Pin Configuration

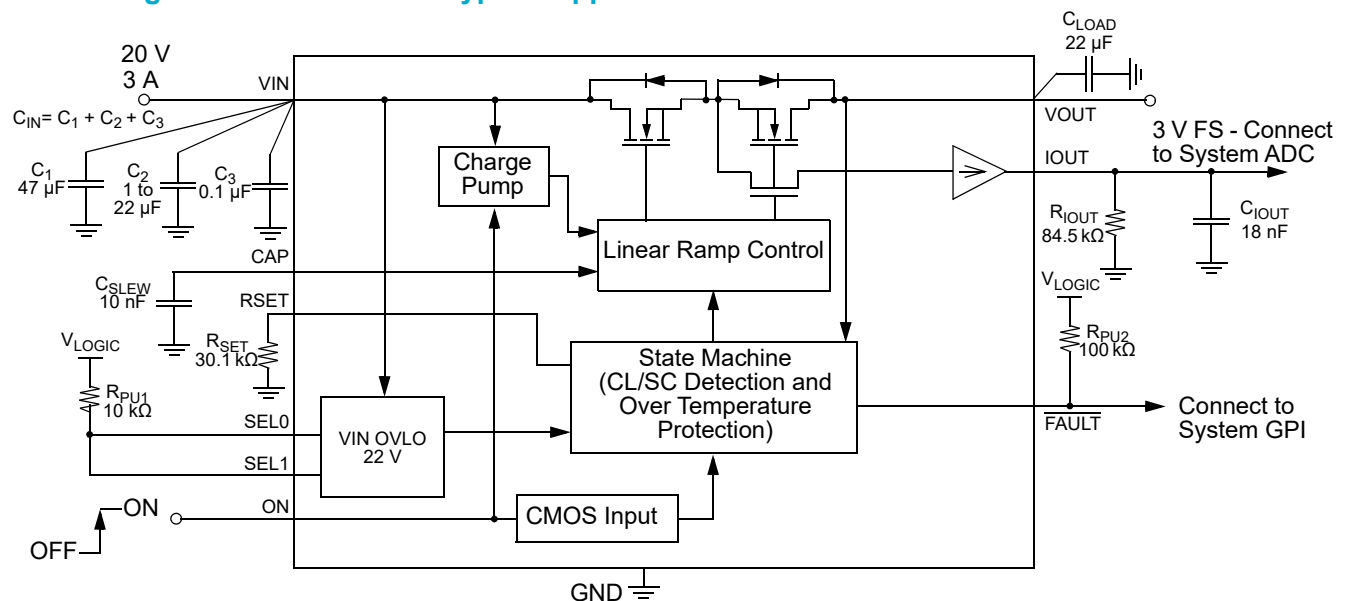


18-pin STQFN
1.6 x 3.0 mm, 0.40mm pitch
(Top View)

Applications

- Power-Rail Switching
- Multifunction Printers
- Large-format Copiers
- Telecommunications Equipment
- High-performance Computing
- 4.5 V and 20 V Point-of-Load Power Distribution
- Motor Drives

Block Diagram and a 20 V / 3 A Typical Application Circuit



A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Pin Description

Pin #	Pin Name	Type	Pin Description
1	ON	Input	A low-to-high transition on this pin initiates the operation of the SLG59H1020V's state machine. ON is an asserted HIGH, level-sensitive CMOS input with $ON_{V_{IL}} < 0.3 V$ and $ON_{V_{IH}} > 0.9 V$. As the ON pin input circuit does not have an internal pull-down resistor, connect this pin to a general-purpose output (GPO) of a microcontroller, an application processor, or a system controller – do not allow this pin to be open-circuited.
2	SEL0	Input	As level-sensitive, CMOS inputs with $V_{IL} < 0.3 V$ and $V_{IH} > 1.65 V$, the SEL0 (LSB) and the SEL1 (MSB) pins select one of four V_{IN} overvoltage lockout thresholds. Please see the Applications Section for additional information and the Electrical Characteristics table for the V_{IN} overvoltage thresholds. A logic LOW on either pin is achieved by connecting the pin of interest to GND; a logic HIGH on either pin is achieved by connecting a 10 kΩ external resistor from the pin in question to the system's local logic supply.
3	GND	GND	Pin 3 is the main ground connection for the SLG59H1020V's internal charge pump, its gate driver and current-limit circuits as well as its internal state machine. Therefore, use a short, stout connection from Pin 3 to the system's analog or power plane.
4-8	VIN	MOSFET	VIN supplies the power for the operation of the SLG59H1020V, its internal control circuitry, and the drain terminal of the back-to-back, reverse-blocking nFET power switch. With 5 pins fused together at VIN, connect a 47 μF (or larger) low-ESR capacitor from this pin to ground. Capacitors used at VIN should be rated at 50 V or higher.
9-13	VOUT	MOSFET	Drain terminal of n-channel MOSFET (5 pins fused for VOUT). Connect a 22 μF (or larger) low-ESR capacitor from this pin to ground. Capacitors used at VOUT should be rated at 50 V or higher.
14	SEL1	Input	Please see SEL0 Pin Description above
15	\overline{FAULT}	Output	An open drain output, \overline{FAULT} is asserted within $T_{\overline{FAULT}_{LOW}}$ when a V_{IN} overvoltage, a current-limit, or an over-temperature condition is detected. \overline{FAULT} is deasserted within $T_{\overline{FAULT}_{HIGH}}$ when the fault condition is removed. Connect an 100 kΩ external resistor from the \overline{FAULT} pin to local system logic supply.
16	CAP	Output	A low-ESR, stable dielectric, ceramic surface-mount capacitor connected from CAP pin to GND sets the V_{OUT} slew rate and overall turn-on time of the SLG59H1020V. For best performance, the range for C_{SLEW} values are $10 nF \leq C_{SLEW} \leq 20 nF$ – please see typical characteristics for additional information. Capacitors used at the CAP pin should be rated at 10 V or higher. Please consult Applications Section on how to select C_{SLEW} based on V_{OUT} slew rate and loading conditions.
17	IOUT	Output	IOUT is the SLG59H1020V's power MOSFET load current monitor output. As an analog current output, this signal when applied to a ground-reference resistor generates a voltage proportional to the current through the n-channel MOSFET. The I_{OUT} transfer characteristic is typically 10 μA/A with a voltage compliance range of $0.5 V \leq V_{IOUT} \leq 4 V$. Optimal I_{OUT} linearity is exhibited for $0.5 A \leq I_{DS} \leq 3 A$. In addition, it is recommended to bypass the IOUT pin to GND with a 0.18 nF capacitor.
18	RSET	Input	A 1%-tolerance, metal-film resistor between 30 kΩ and 91 kΩ sets the SLG59H1020V's active current limit. A 91 kΩ resistor sets the SLG59H1020V's active current limit to 1 A and a 30 kΩ resistor sets the active current limit to 3 A.

Ordering Information

Part Number	Type	Production Flow
SLG59H1020V	STQFN 18L FC	Industrial, -40 °C to 85 °C

SLG59H1020V



A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Part Number	Type	Production Flow
SLG59H1020VTR	STQFN 18L FC (Tape and Reel)	Industrial, -40 °C to 85 °C

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Absolute Maximum Ratings

Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
V_{IN} to GND	Power Switch Input Voltage to GND	Continuous	-0.3	--	30	V
		Maximum pulsed V_{IN} , pulse width < 0.1 s	--	--	32	V
V_{OUT} to GND	Power Switch Output Voltage to GND		-0.3	--	V_{IN}	V
ON, SEL[1,0], CAP, RSET, IOUT, and FAULT to GND	ON, SEL[1,0], CAP, RSET, IOUT, and FAULT Pin Voltages to GND		-0.3	--	7	V
T_S	Storage Temperature		-65	--	150	°C
ESD _{HBM}	ESD Protection	Human Body Model	2000	--	--	V
ESD _{CDM}	ESD Protection	Charged Device Model	500	--	--	V
MSL	Moisture Sensitivity Level		1			
θ_{JA}	Thermal Resistance	1.6 x 3.0 mm 18L STQFN; Determined with the device mounted onto a 1 in ² , 1 oz. copper pad of FR-4 material	--	40	--	°C/W
$T_{J,MAX}$	Maximum Junction Temperature		--	150	--	°C
MOSFET $I_{DS,CONT}$	Continuous Current from V_{IN} to V_{OUT}	$T_J < 150$ °C	--	--	3	A
MOSFET $I_{DS,PEAK}$	Peak Current from V_{IN} to V_{OUT}	Maximum pulsed switch current, pulse width < 1 ms	--	--	5	A

Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics

4.5 V ≤ V_{IN} ≤ 20 V; C_{IN} = 47 μF, T_A = -40 °C to 85 °C, unless otherwise noted. Typical values are at T_A = 25 °C

Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
V_{IN}	Operating Input Voltage		4.5	--	20	V
$V_{IN(OVLO)}$	V_{IN} Overvoltage Lockout Threshold	$V_{IN} \uparrow$; SEL[1,0] = [0,0]	5.5	6.0	6.5	V
		$V_{IN} \uparrow$; SEL[1,0] = [0,1]	10.2	10.8	11.4	V
		$V_{IN} \uparrow$; SEL[1,0] = [1,0]	16.0	17.0	18.0	V
		$V_{IN} \uparrow$; SEL[1,0] = [1,1]	20.5	22.0	23.5	V
$V_{IN(OVLOHYST)}$	V_{IN} Overvoltage Lockout Hysteresis		--	2	--	%
I_Q	Quiescent Supply Current	ON = HIGH; $I_{DS} = 0$ A	--	0.5	0.6	mA
I_{SHDN}	OFF Mode Supply Current	ON = LOW; $I_{DS} = 0$ A	--	1	3	μA
$R_{DS,ON}$	ON Resistance	$T_A = 25$ °C; $I_{DS} = 0.1$ A	--	50	52	mΩ
		$T_A = 85$ °C; $I_{DS} = 0.1$ A	--	65	70	mΩ
MOSFET I_{DS}	Current from V_{IN} to V_{OUT}	Continuous	--	--	3	A
$I_{REVERSE}$	MOSFET Reverse-Leakage Current	$V_{IN} = 0$ V; $V_{OUT} = 20$ V; ON = 0 V	--	--	3	μA
I_{LIMIT}	Active Current Limit, I_{ACL}	$V_{OUT} > 0.5$ V; $R_{SET} = 30.1$ kΩ	3	3.2	3.4	A
	Short-circuit Current Limit, I_{SCL}	$V_{OUT} < 0.5$ V; $V_{IN} = 4.5$ V; $R_{LOAD} = 0.5$ Ω	--	0.8	--	A

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Electrical Characteristics (continued)

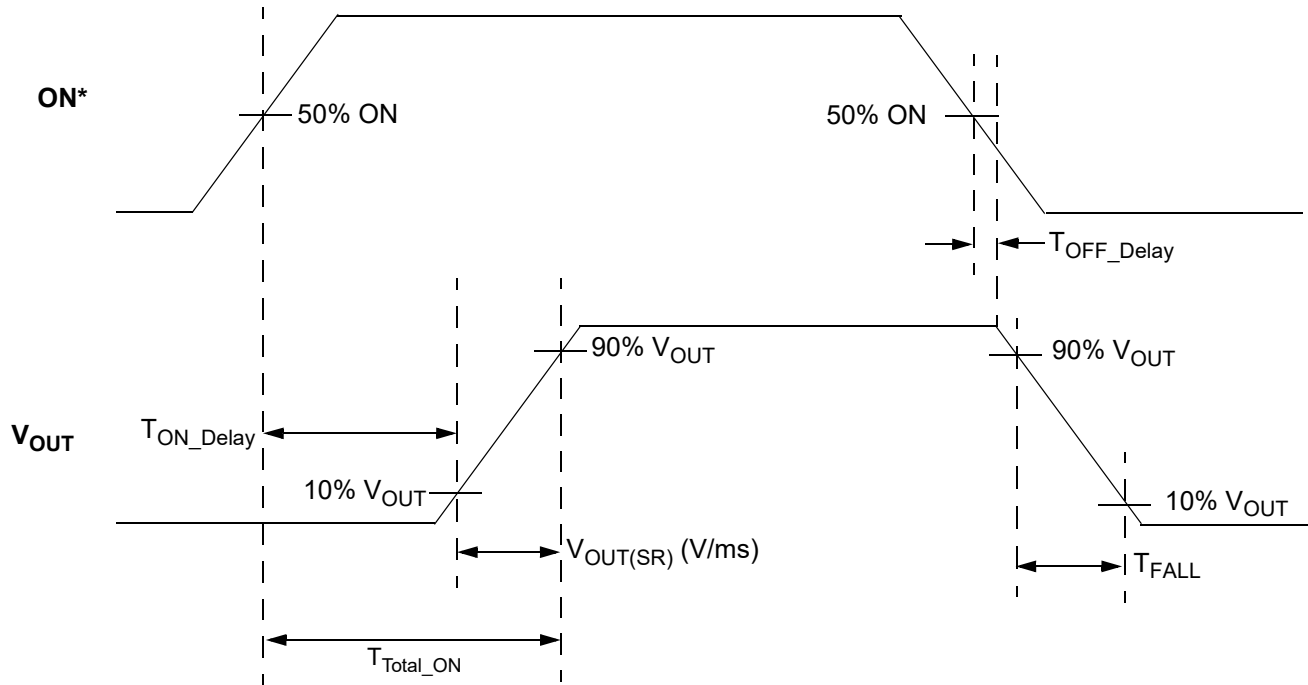
4.5 V \leq V_{IN} \leq 20 V; C_{IN} = 47 μ F, T_A = -40 °C to 85 °C, unless otherwise noted. Typical values are at T_A = 25 °C

Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
T_{ACL}	Active Current Limit Response Time	$R_{SET} = 51.6 \text{ k}\Omega$	--	120	--	μ s
I_{OUT}	MOSFET Current Analog Monitor Output	$I_{DS} = 1 \text{ A}$	9.3	10	10.7	μ A
		$I_{DS} = 3 \text{ A}$	28.5	30	31.5	μ A
T_{IOUT}	I_{OUT} Response Time to Change in Main MOSFET Current	$C_{IOUT} = 180 \text{ pF}$; Step load 0 to 2.4 A; 0% to 90% I_{OUT}	--	45	--	μ s
C_{LOAD}	Output Load Capacitance	C_{LOAD} connected from V_{OUT} to GND	--	22	--	μ F
T_{ON_Delay}	ON Delay Time	50% ON to 10% V_{OUT} \uparrow ; $V_{IN} = 4.5 \text{ V}$; $C_{SLEW} = 10 \text{ nF}$; $R_{LOAD} = 100 \Omega$, $C_{LOAD} = 10 \mu\text{F}$	--	0.3	0.5	ms
		50% ON to 10% V_{OUT} \uparrow ; $V_{IN} = 20 \text{ V}$; $C_{SLEW} = 10 \text{ nF}$; $R_{LOAD} = 100 \Omega$, $C_{LOAD} = 10 \mu\text{F}$	--	0.7	1.2	ms
T_{Total_ON}	Total Turn ON Time	50% ON to 90% V_{OUT} \uparrow	Set by External C_{SLEW}^1			ms
		50% ON to 90% V_{OUT} \uparrow ; $V_{IN} = 4.5 \text{ V}$; $C_{SLEW} = 10 \text{ nF}$; $R_{LOAD} = 100 \Omega$, $C_{LOAD} = 10 \mu\text{F}$	--	1.5	2.1	ms
		50% ON to 90% V_{OUT} \uparrow ; $V_{IN} = 20 \text{ V}$; $C_{SLEW} = 10 \text{ nF}$; $R_{LOAD} = 100 \Omega$, $C_{LOAD} = 10 \mu\text{F}$	--	6.5	8	ms
$V_{OUT(SR)}$	V_{OUT} Slew rate	50% ON to 90% V_{OUT} \uparrow	Set by External C_{SLEW}^1			V/ms
		10% to 90% V_{OUT} \uparrow ; $V_{IN} = 4.5 \text{ V to } 20 \text{ V}$; $C_{SLEW} = 10 \text{ nF}$; $R_{LOAD} = 100 \Omega$, $C_{LOAD} = 10 \mu\text{F}$	2.7	3.2	3.9	V/ms
T_{OFF_Delay}	OFF Delay Time	50% ON to V_{OUT} Fall Start \downarrow ; $V_{IN} = 4.5 \text{ V to } 20 \text{ V}$ $R_{LOAD} = 100 \Omega$, No C_{LOAD}	--	15	--	μ s
T_{FALL}	V_{OUT} Fall Time	90% V_{OUT} to 10% V_{OUT} \downarrow ; ON = HIGH-to-LOW; $V_{IN} = 4.5 \text{ V to } 20 \text{ V}$; $R_{LOAD} = 100 \Omega$, No C_{LOAD}	10.4	12.7	14.3	μ s
$\overline{T_{FAULT_LOW}}$	\overline{FAULT} Assertion Time	Abnormal Step Load Current event to \overline{FAULT} \downarrow ; $I_{ACL} = 1 \text{ A}$; $V_{IN} = 20 \text{ V}$; $R_{SET} = 91 \text{ k}\Omega$; switch in 20 Ω load	--	80	--	μ s
$\overline{T_{FAULT_HIGH}}$	\overline{FAULT} De-assertion Time	Delay to \overline{FAULT} \uparrow after fault condition is removed; $I_{ACL} = 1 \text{ A}$; $V_{IN} = 20 \text{ V}$; $R_{SET} = 91 \text{ k}\Omega$; switch out 20 Ω load	--	180	--	μ s
$\overline{FAULT_VOL}$	\overline{FAULT} Output Low Voltage	$I_{FAULT} = 1 \text{ mA}$	--	0.2	--	V
ON_ V_{IH}	ON Pin Input High Voltage		0.9	--	5	V
ON_ V_{IL}	ON Pin Input Low Voltage		-0.3	0	0.3	V
SEL[1,0]_ V_{IH}	SEL[1,0] pins Input High Voltage		1.65	--	4.5	V
SEL[1,0]_ V_{IL}	SEL[1,0] pins Input Low Voltage		-0.3	--	0.3	V
$I_{ON(Leakage)}$	ON Pin Leakage Current	1 V \leq ON \leq 5 V or ON = GND	--	--	1	μ A
THERM _{ON}	Thermal Protection Shutdown Threshold		--	125	--	°C
THERM _{OFF}	Thermal Protection Restart Threshold		--	100	--	°C

Notes:

1. Refer to typical Timing Parameter vs. C_{SLEW} performance charts for additional information when available.

T_{Total_ON} , T_{ON_Delay} and Slew Rate Measurement

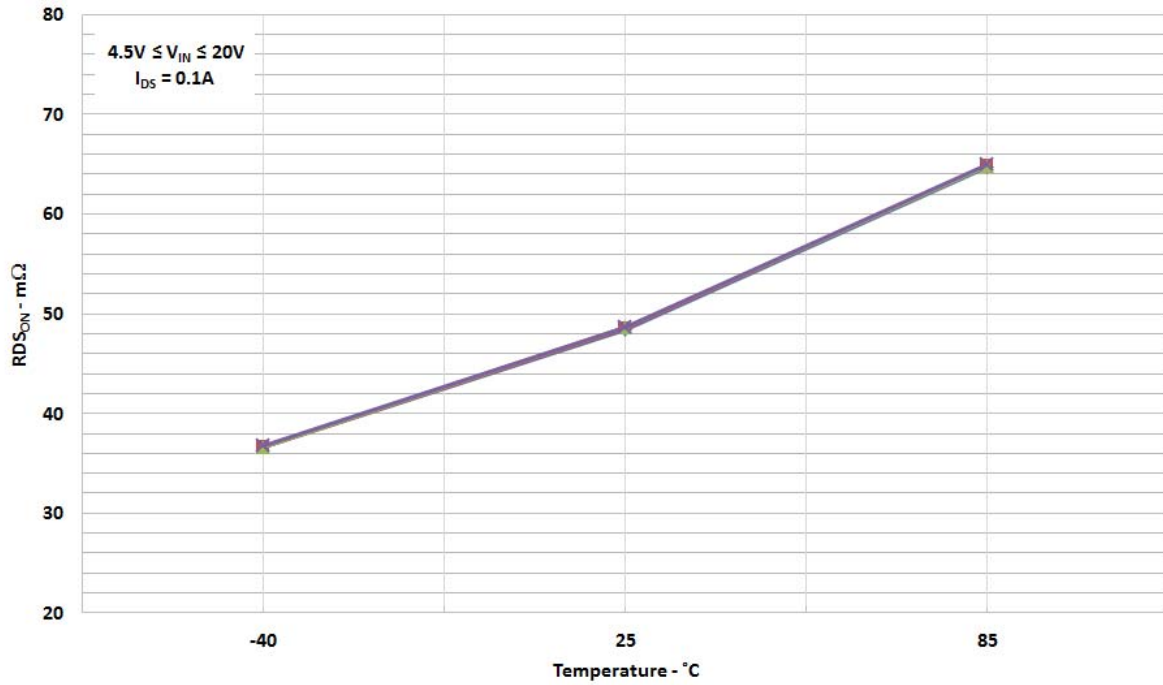


*Rise and Fall Times of the ON Signal are 100 ns

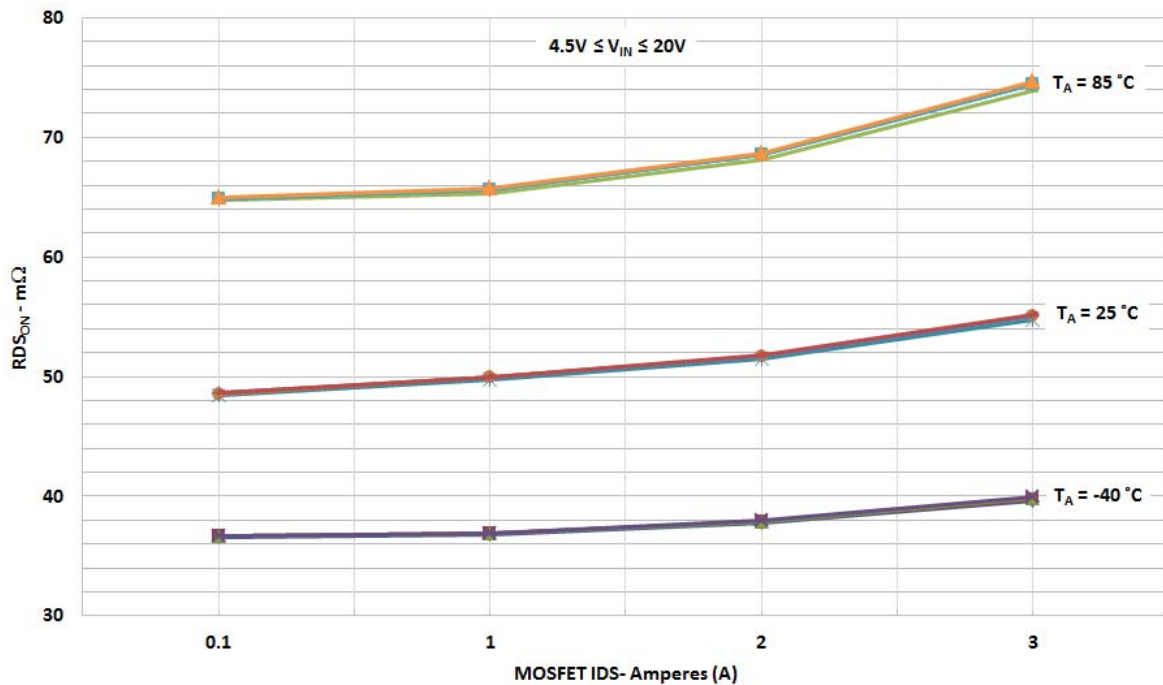
A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Typical Performance Characteristics

$R_{DS(ON)}$ vs. Temperature and V_{IN}

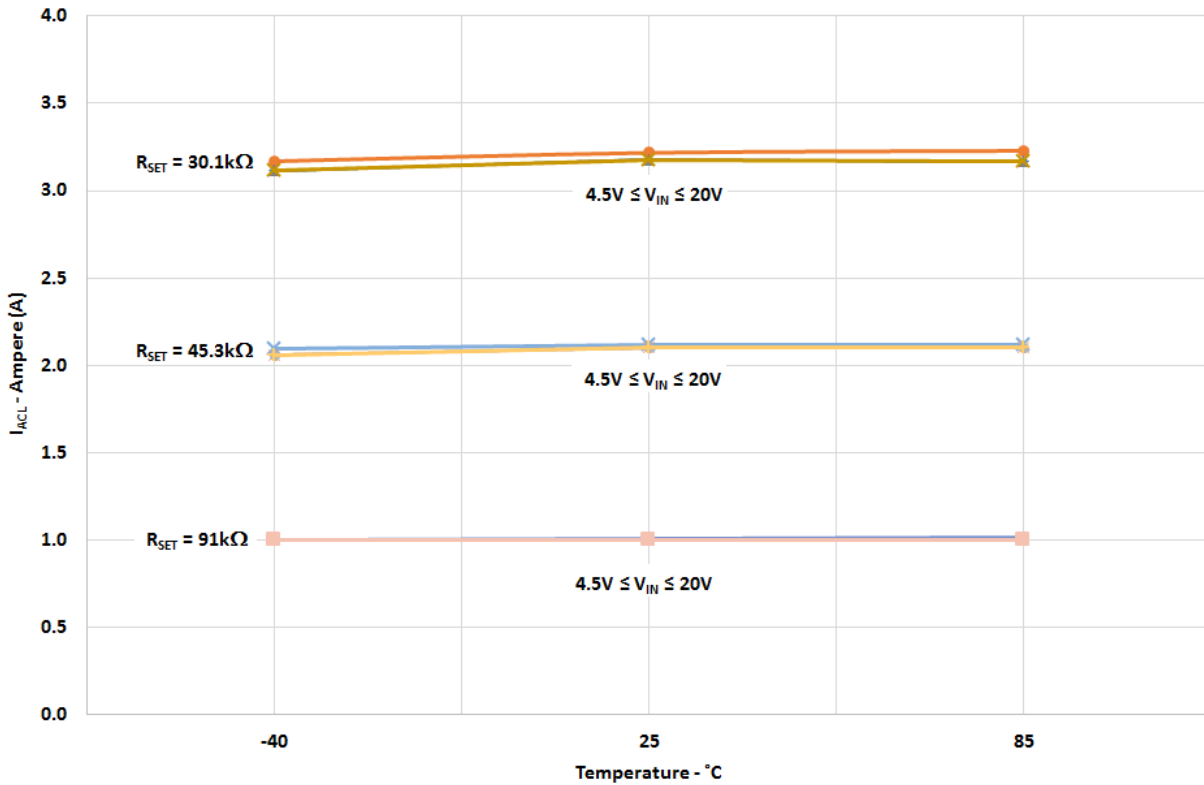


$R_{DS(ON)}$ vs. MOSFET I_{DS} , V_{IN} , and Temperature

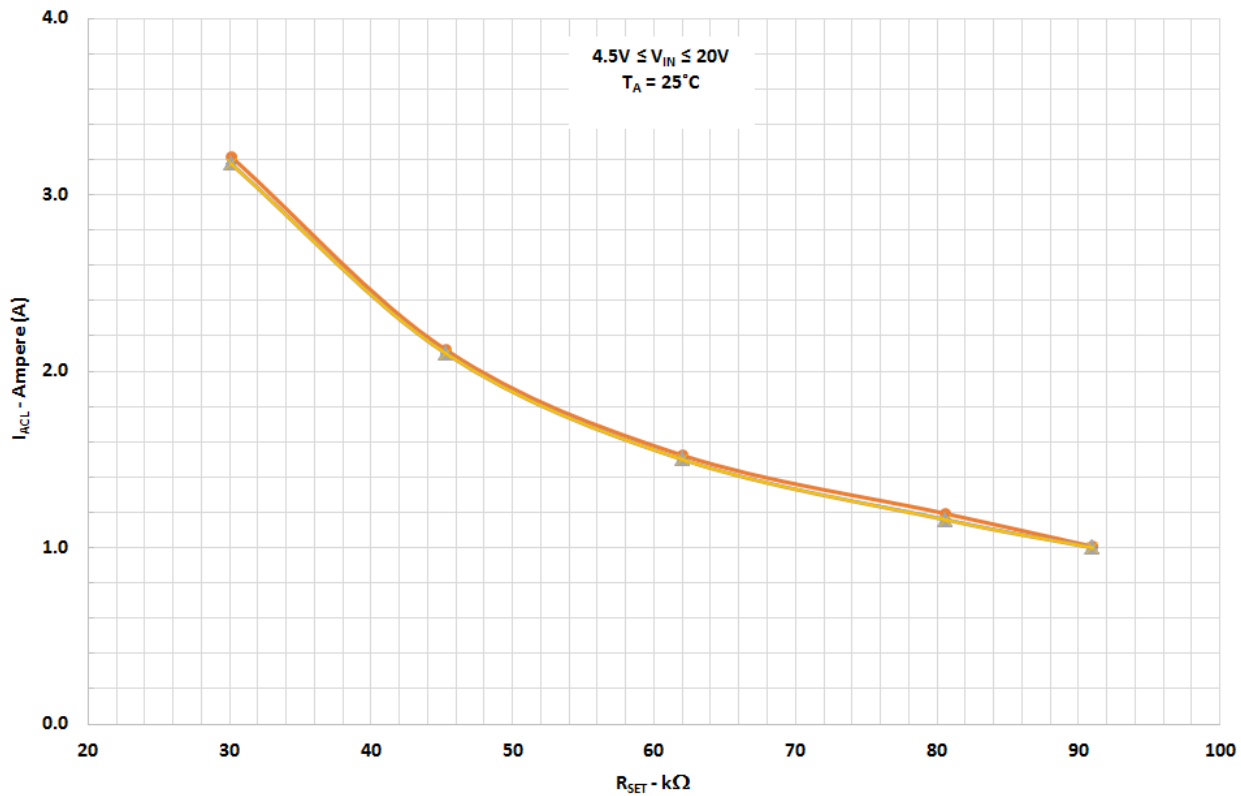


A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

I_{ACL} vs. Temperature and R_{SET}

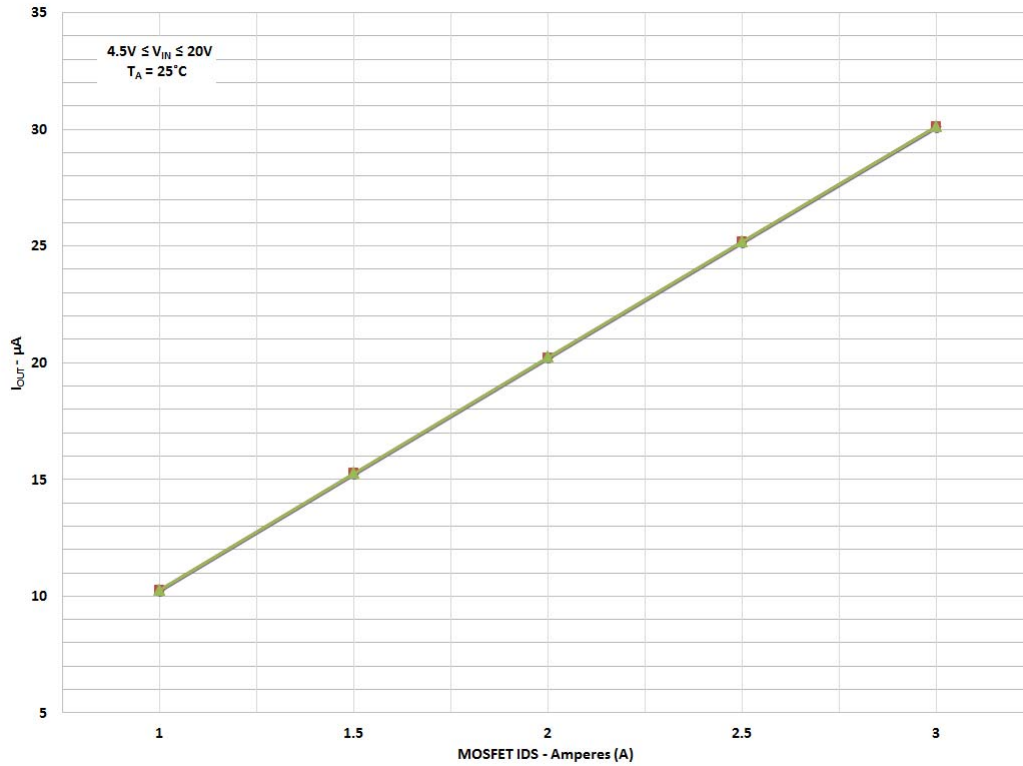


I_{ACL} vs. R_{SET} and V_{IN}

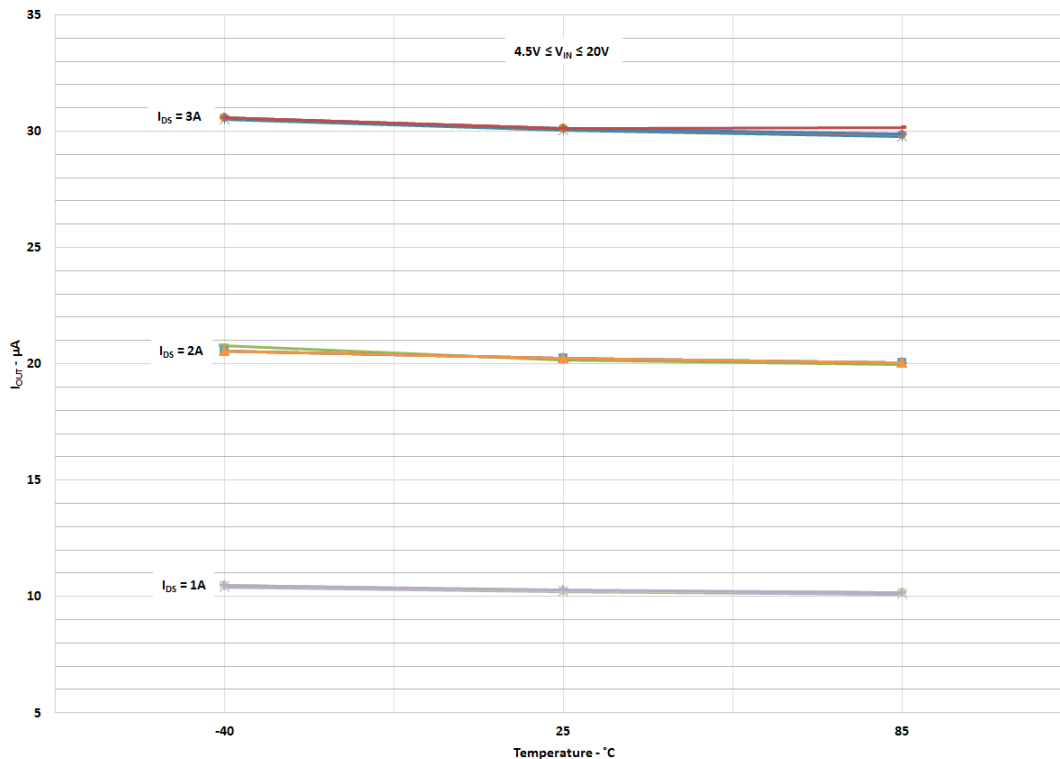


A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

I_{OUT} vs. MOSFET I_{DS} and V_{IN}



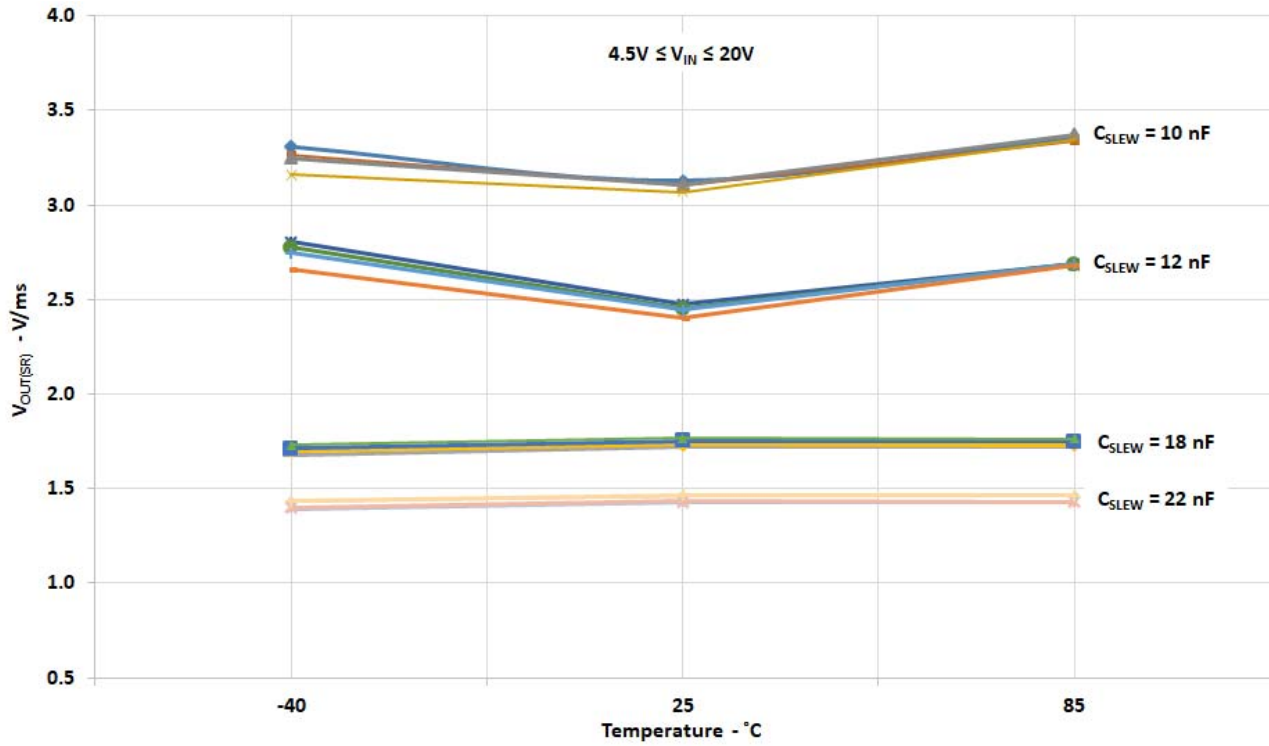
I_{OUT} vs. Temperature and MOSFET I_{DS}



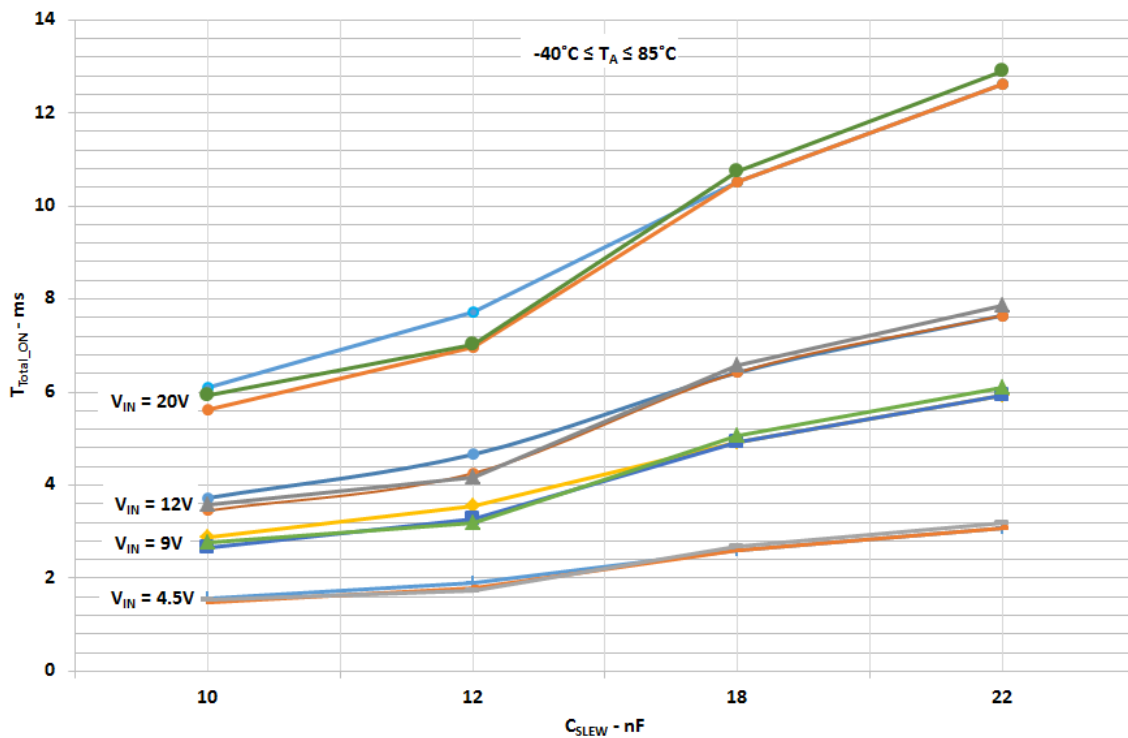
SLG59H1020V

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V_{OUT} Slew Rate vs. Temperature, V_{IN} , and C_{SLEW}



T_{Total_ON} vs. C_{SLEW} , V_{IN} , and Temperature



A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

SLG59H1020V Application Diagram

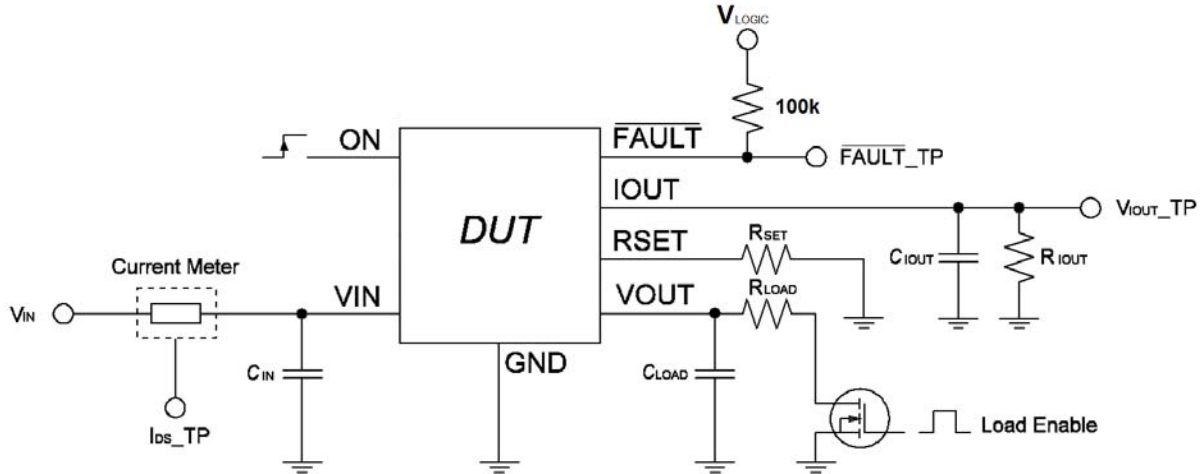


Figure 1. Test setup Application Diagram

Typical Turn-on Waveforms

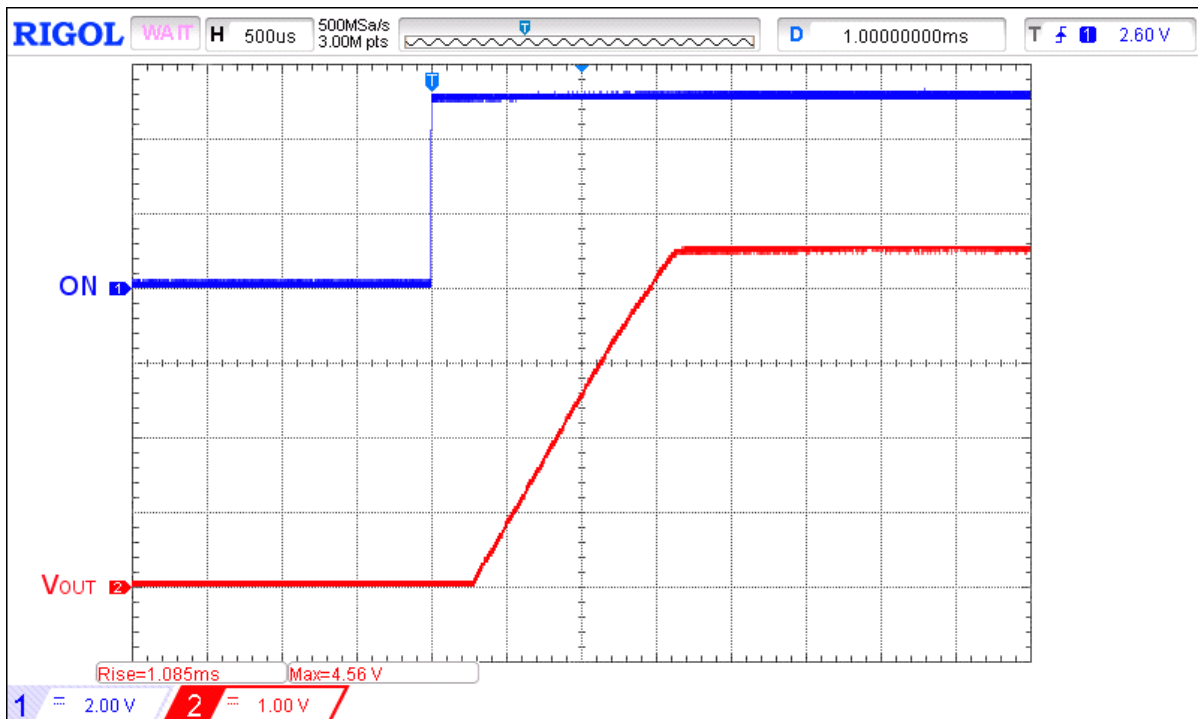


Figure 2. Typical Turn ON operation waveform for $V_{IN} = 4.5\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

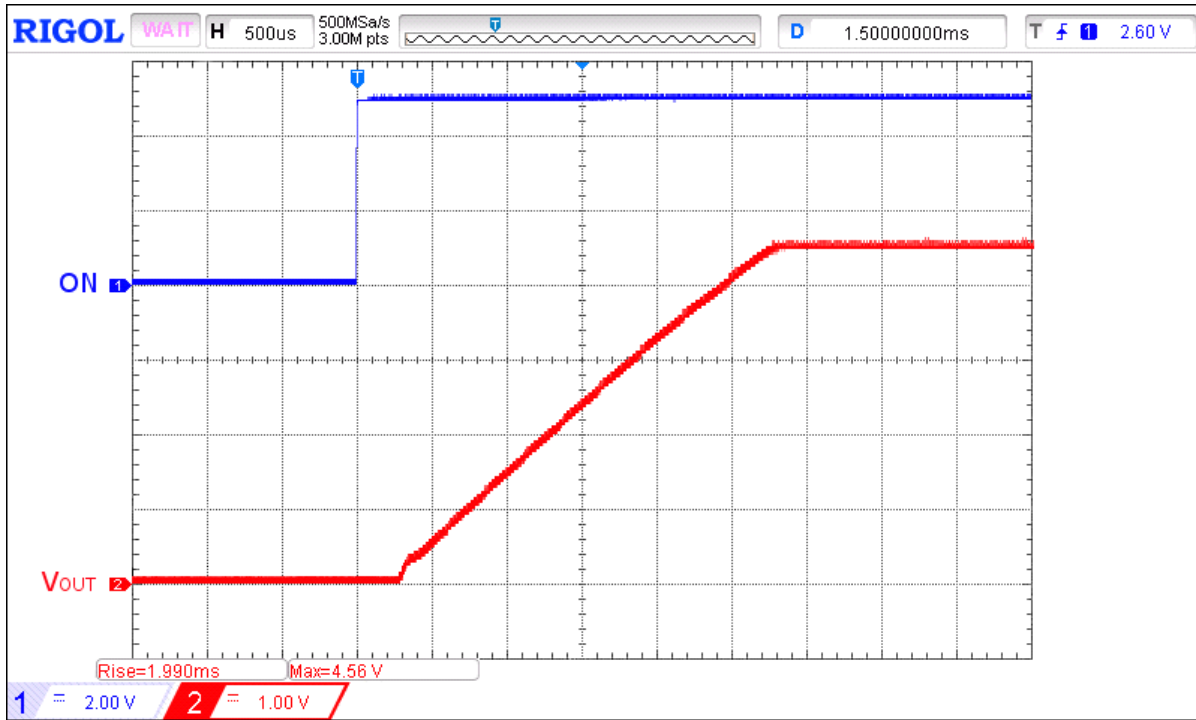


Figure 3. Typical Turn ON operation waveform for $V_{IN} = 4.5\text{ V}$, $C_{SLEW} = 18\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

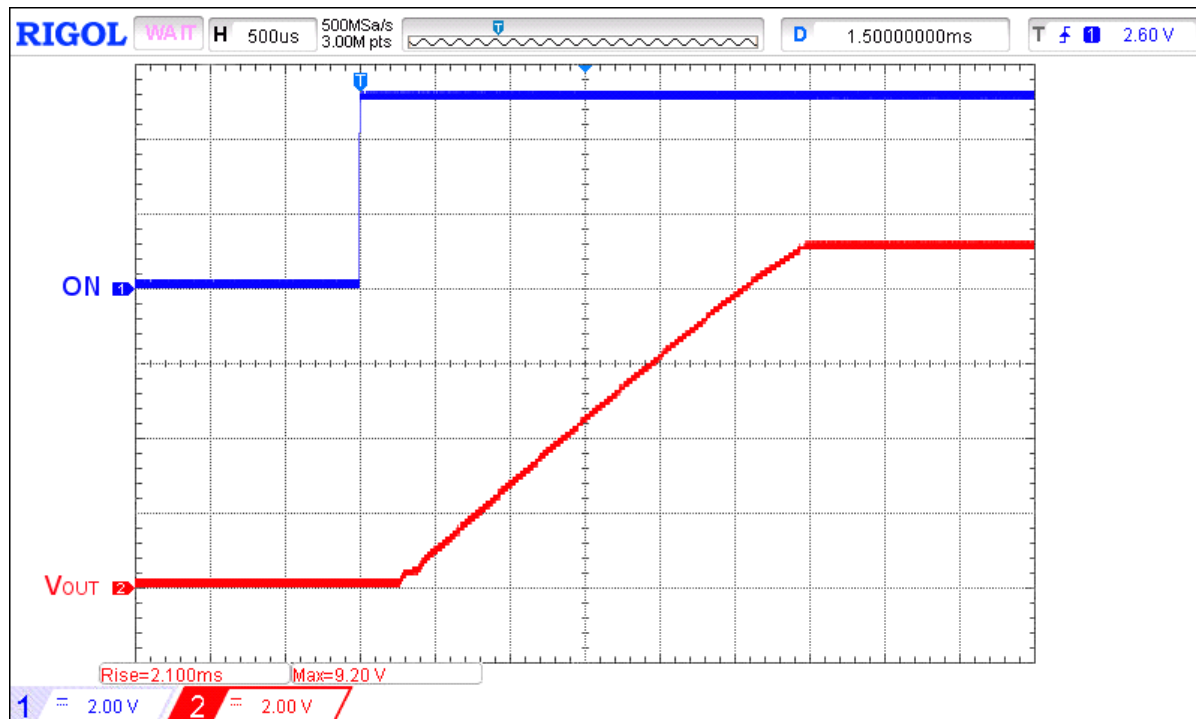


Figure 4. Typical Turn ON operation waveform for $V_{IN} = 9\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

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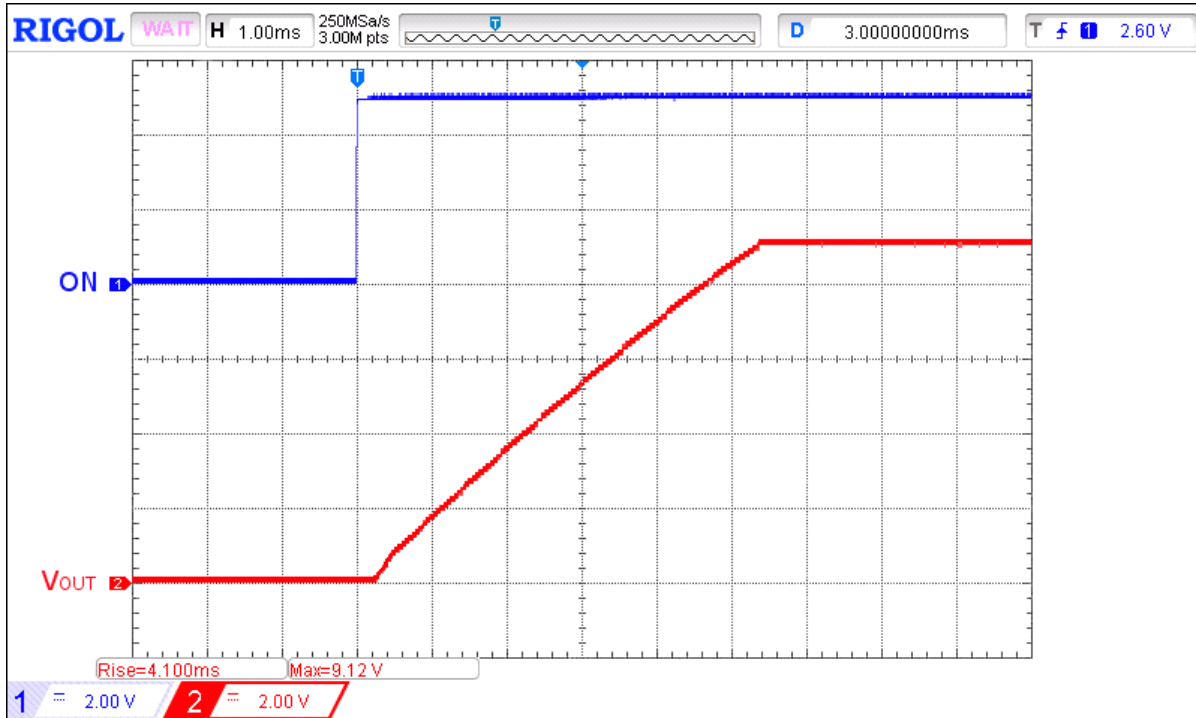


Figure 5. Typical Turn ON operation waveform for $V_{IN} = 9\text{ V}$, $C_{SLEW} = 18\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

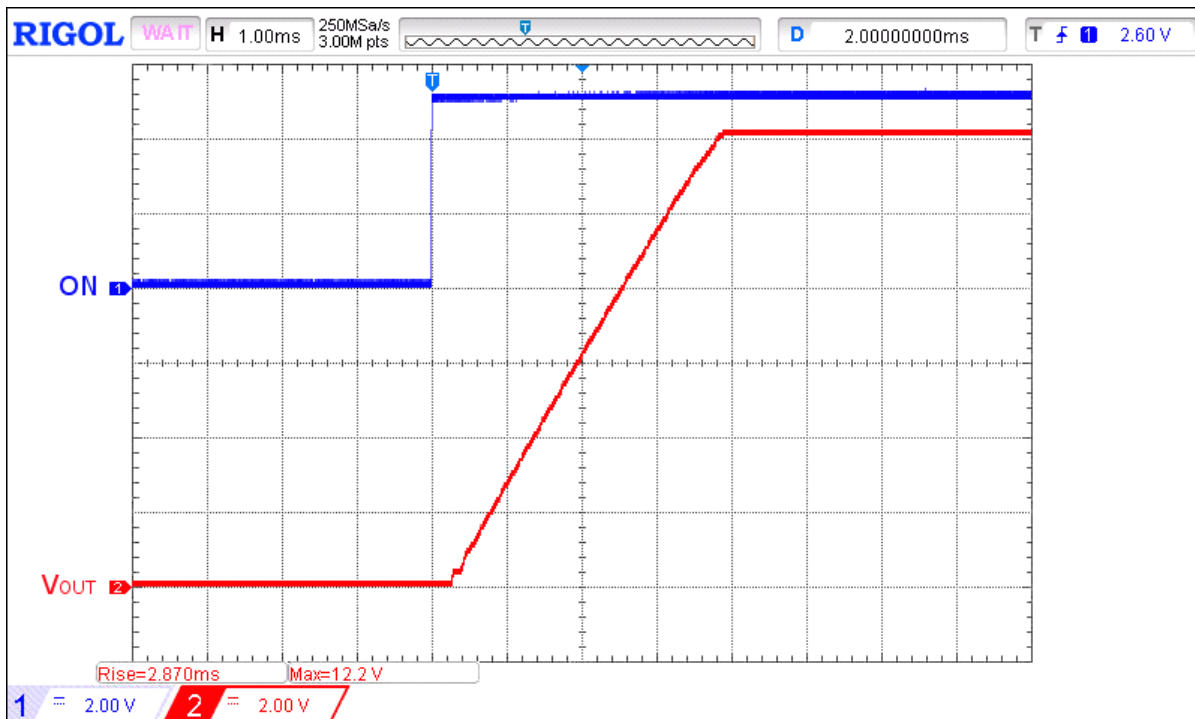


Figure 6. Typical Turn ON operation waveform for $V_{IN} = 12\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

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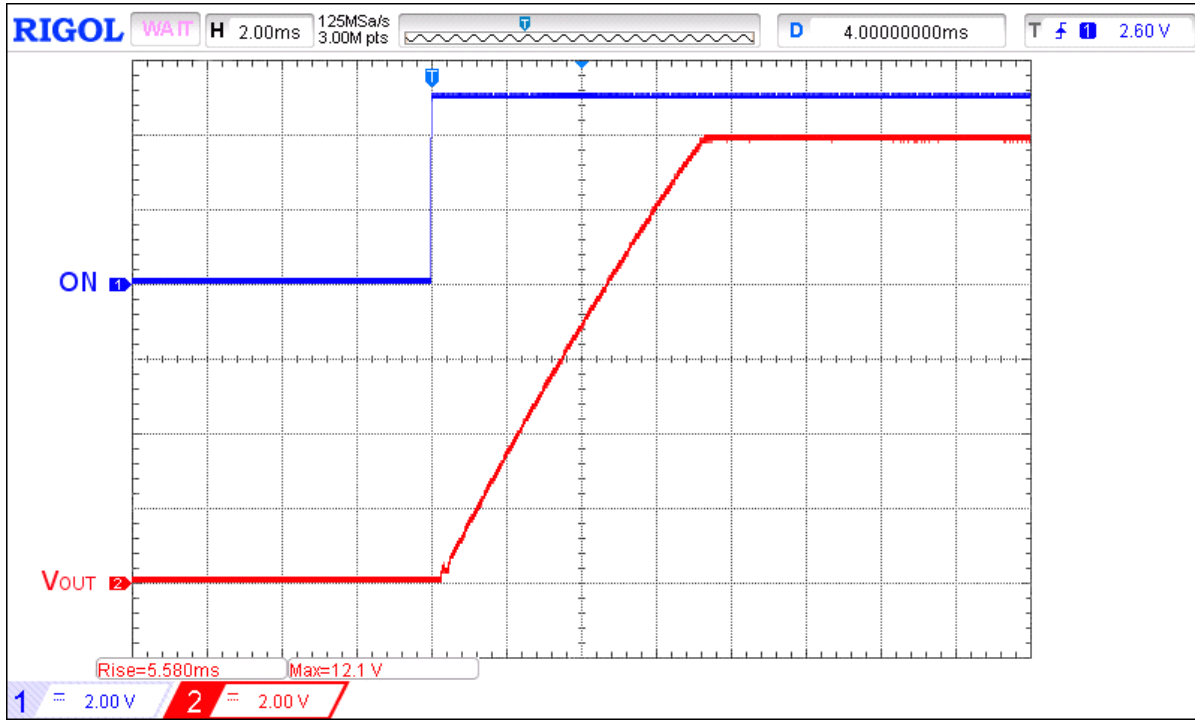


Figure 7. Typical Turn ON operation waveform for $V_{IN} = 12\text{ V}$, $C_{SLEW} = 18\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

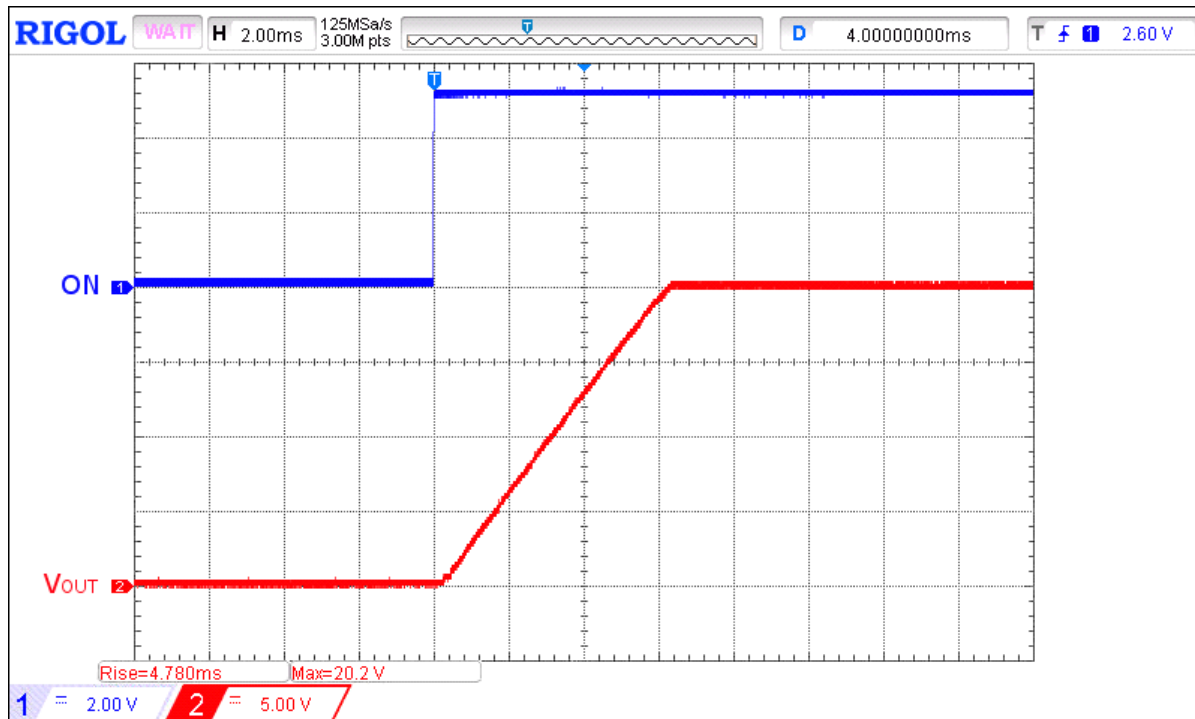


Figure 8. Typical Turn ON operation waveform for $V_{IN} = 20\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

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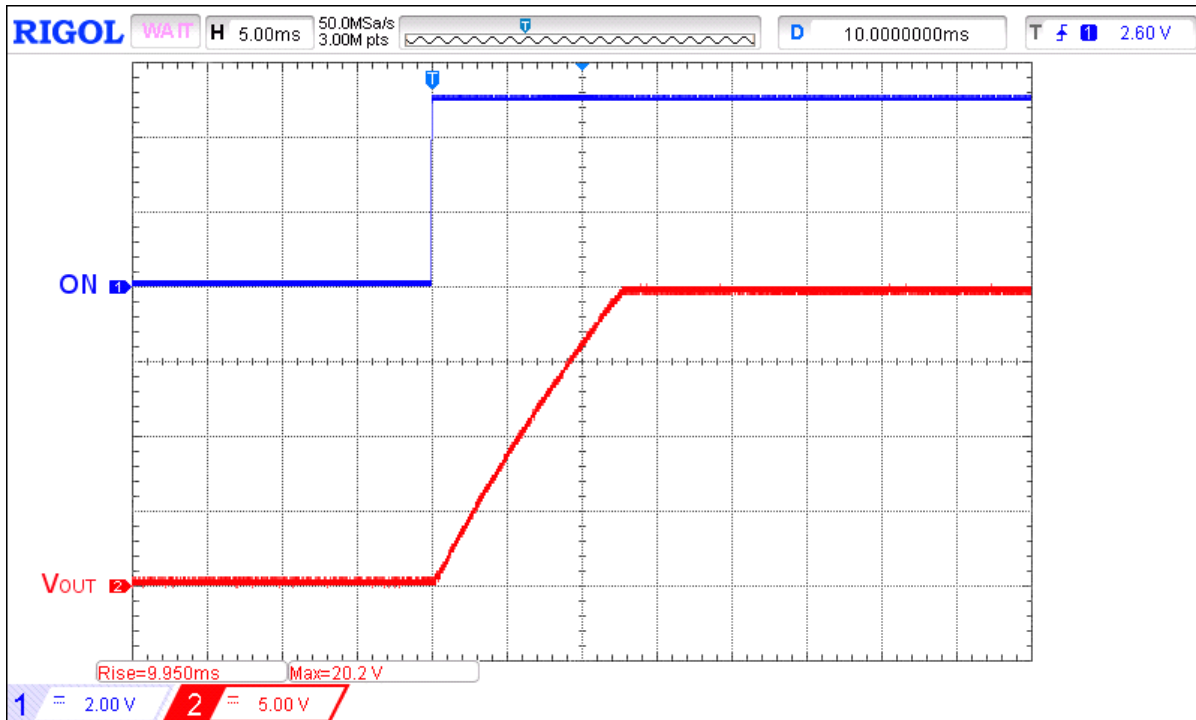


Figure 9. Typical Turn ON operation waveform for $V_{IN} = 20\text{ V}$, $C_{SLEW} = 18\text{ nF}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 100\text{ }\Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Typical Turn-off Waveforms

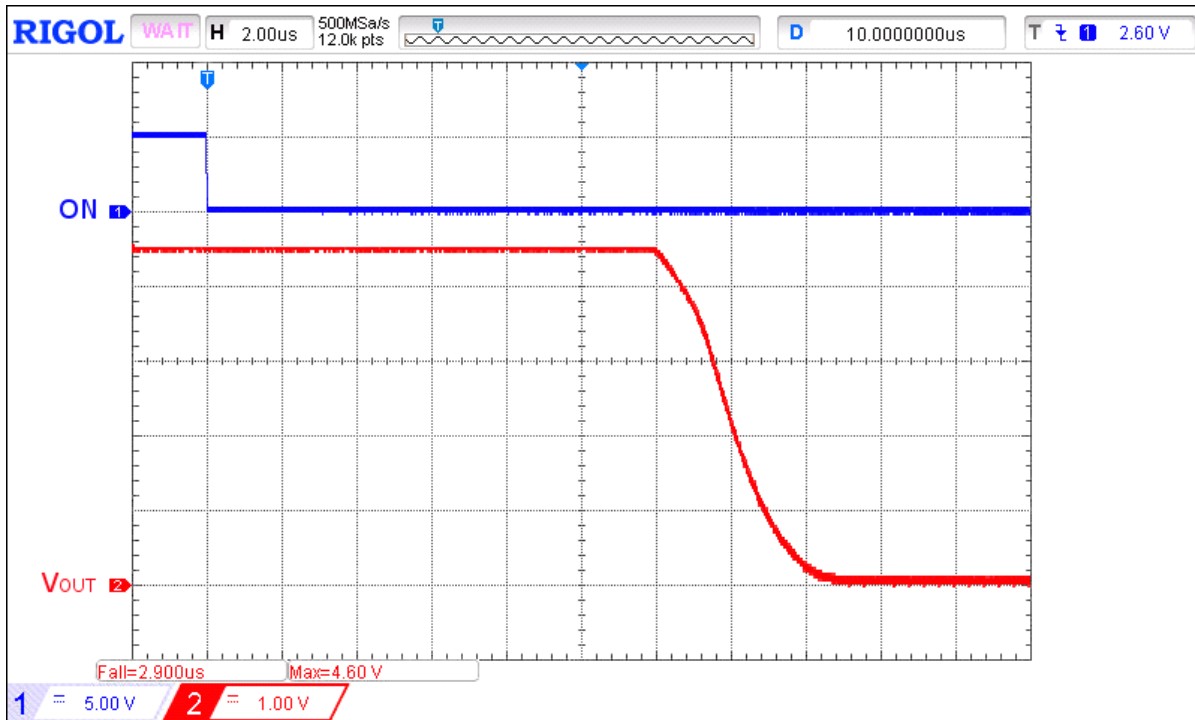


Figure 10. Typical Turn OFF operation waveform for $V_{IN} = 4.5\text{ V}$, $C_{SLEW} = 10\text{ nF}$, no C_{LOAD} , $R_{LOAD} = 100\ \Omega$

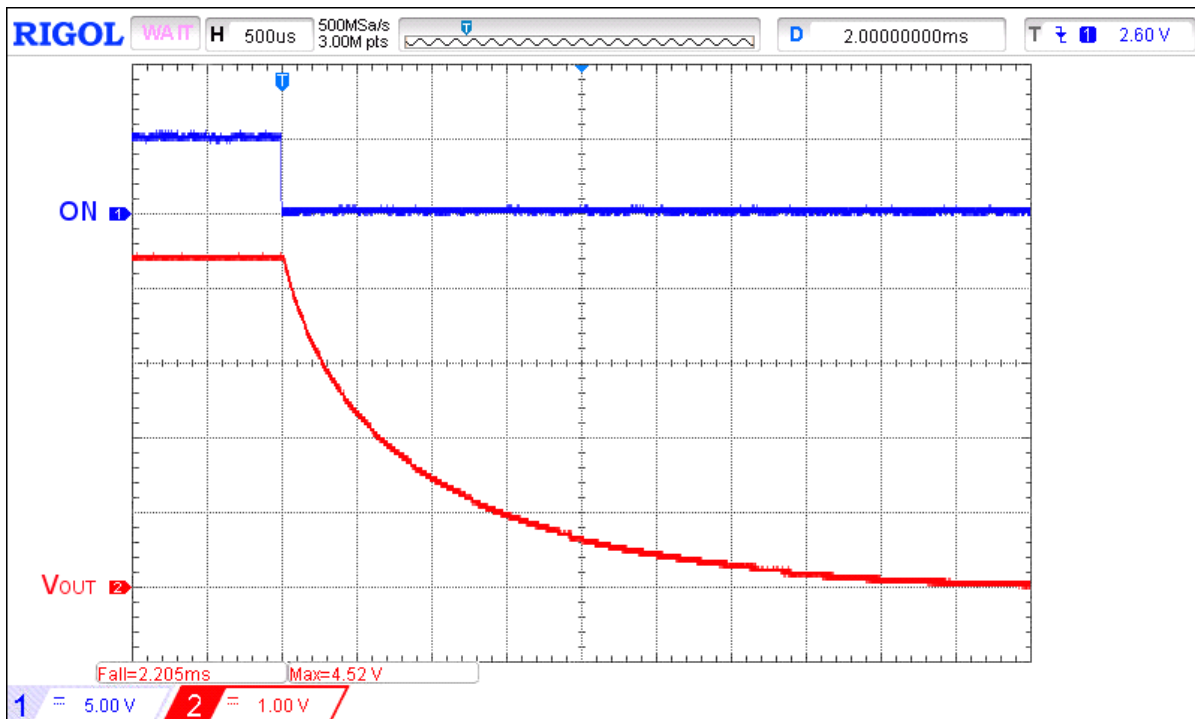


Figure 11. Typical Turn OFF operation waveform for $V_{IN} = 4.5\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 100\ \Omega$

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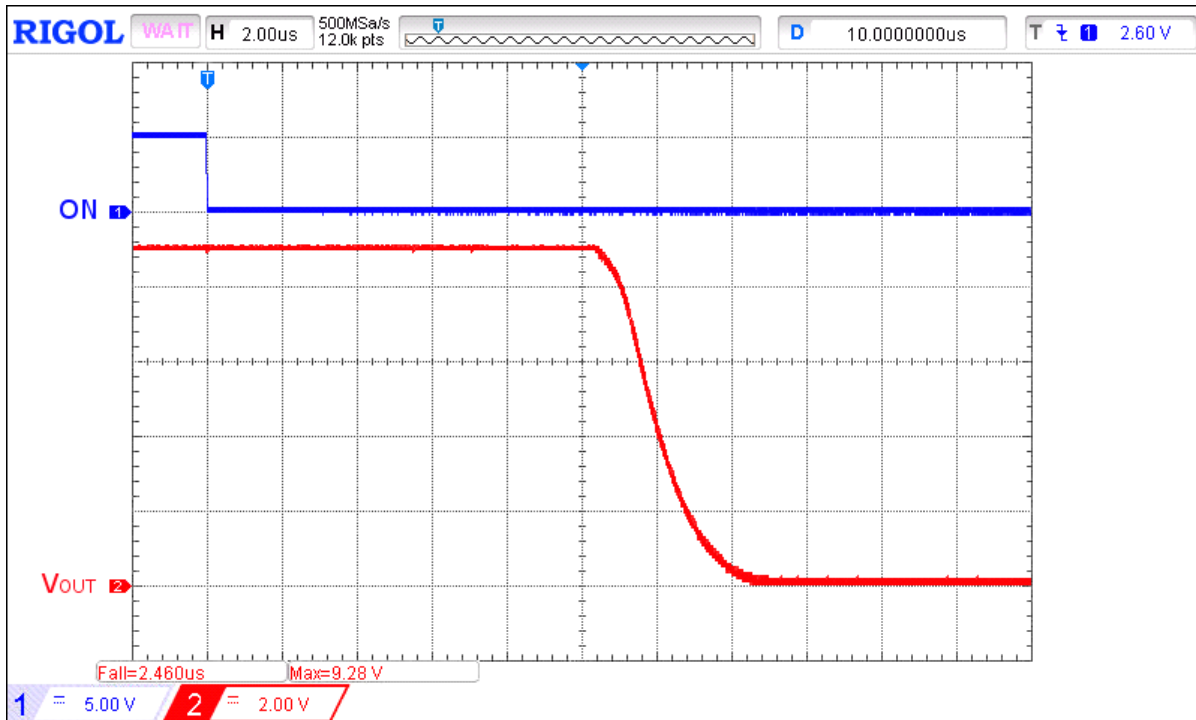


Figure 12. Typical Turn OFF operation waveform for $V_{IN} = 9\text{ V}$, $C_{SLEW} = 10\text{ nF}$, no C_{LOAD} , $R_{LOAD} = 100\ \Omega$

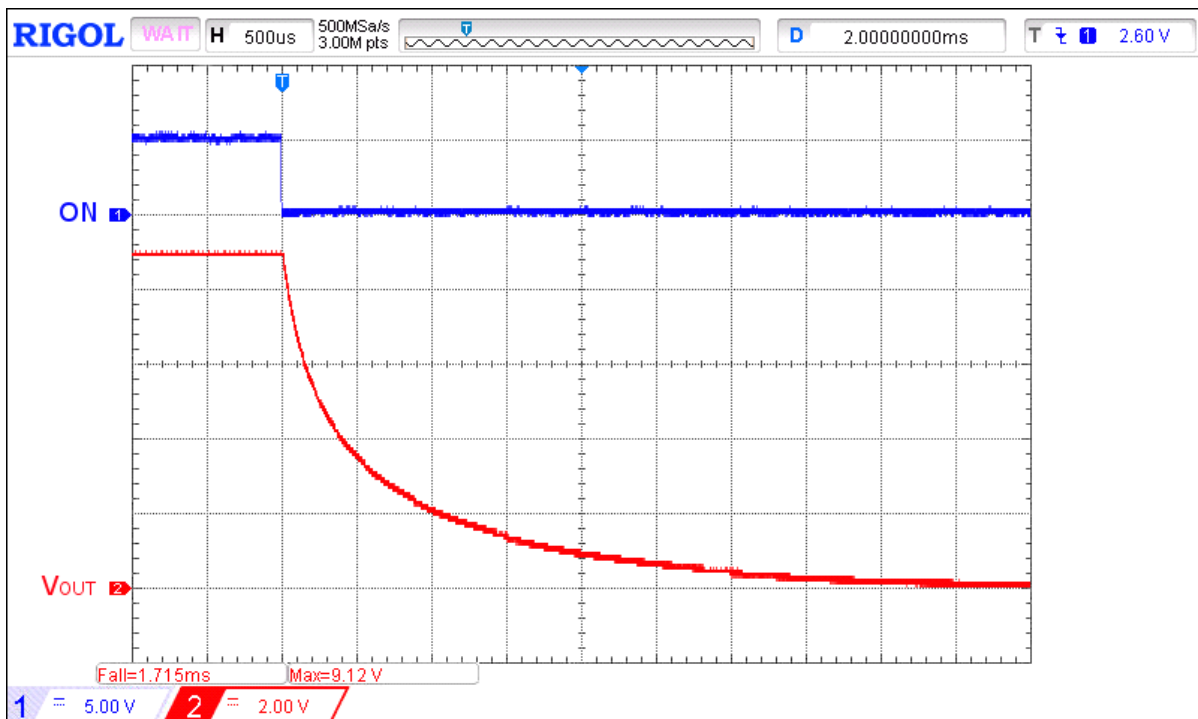


Figure 13. Typical Turn OFF operation waveform for $V_{IN} = 9\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 100\ \Omega$

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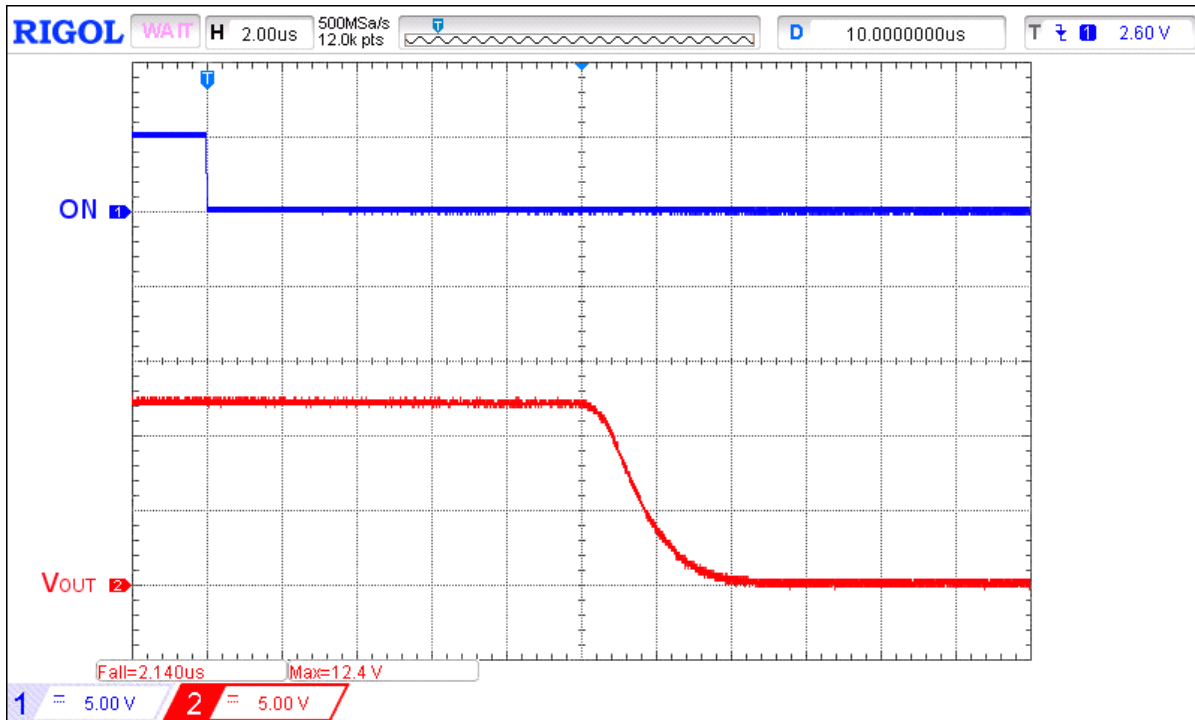


Figure 14. Typical Turn OFF operation waveform for $V_{IN} = 12\text{ V}$, $C_{SLEW} = 10\text{ nF}$, no C_{LOAD} , $R_{LOAD} = 100\ \Omega$

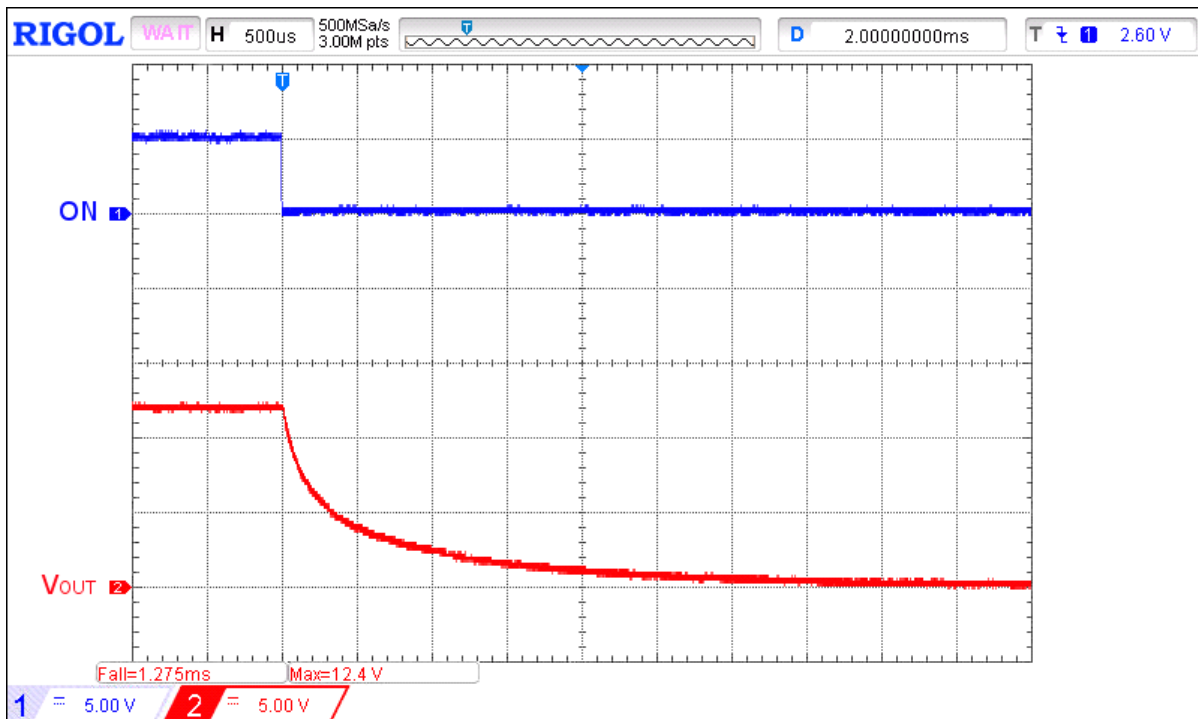


Figure 15. Typical Turn OFF operation waveform for $V_{IN} = 12\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 100\ \Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

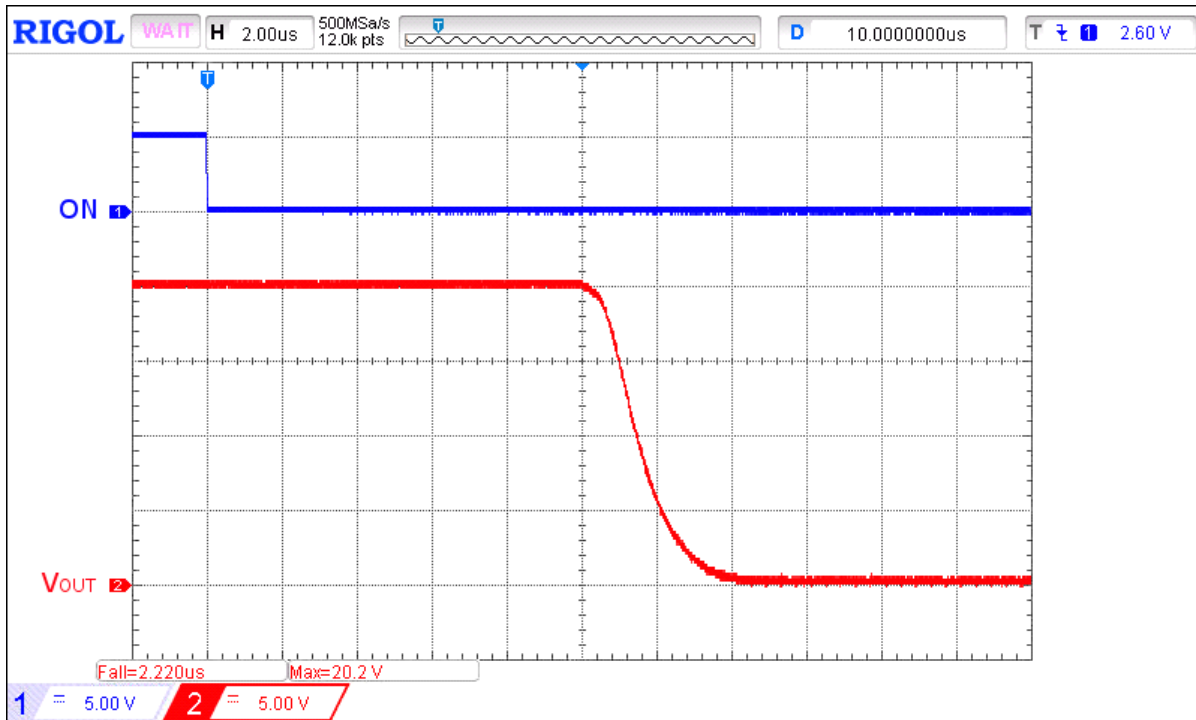


Figure 16. Typical Turn OFF operation waveform for $V_{IN} = 20\text{ V}$, $C_{SLEW} = 10\text{ nF}$, no C_{LOAD} , $R_{LOAD} = 100\ \Omega$

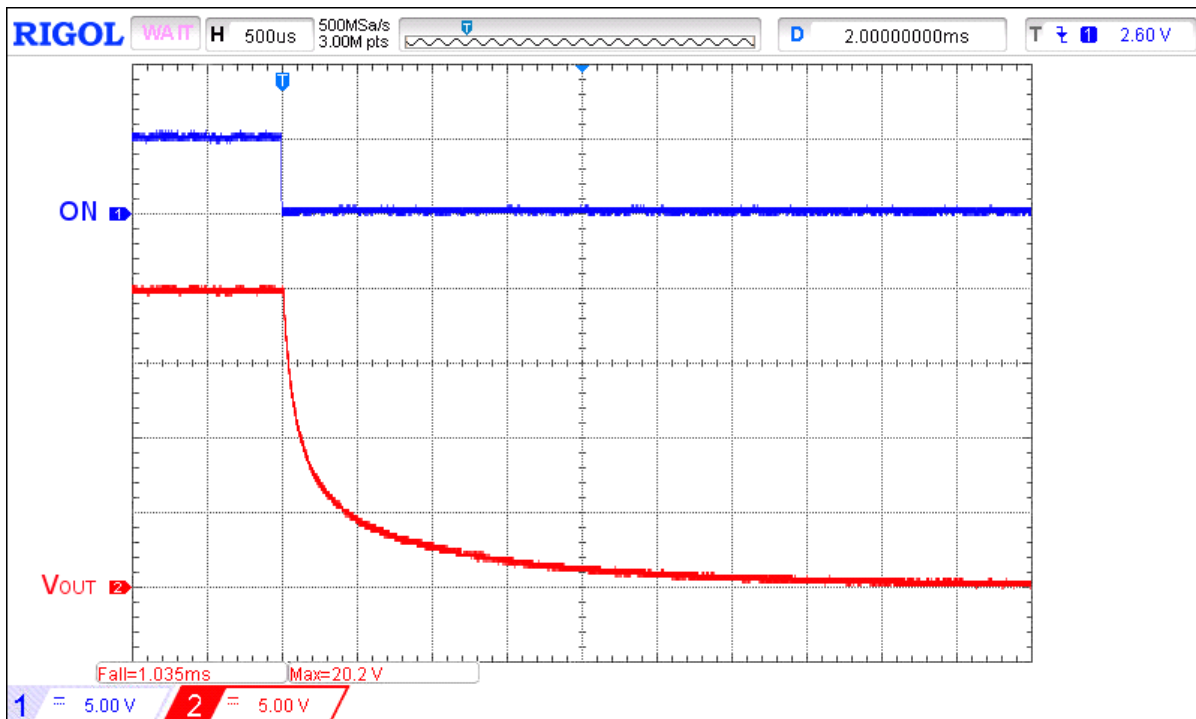


Figure 17. Typical Turn OFF operation waveform for $V_{IN} = 20\text{ V}$, $C_{SLEW} = 10\text{ nF}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 100\ \Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Typical ACL Operation Waveforms

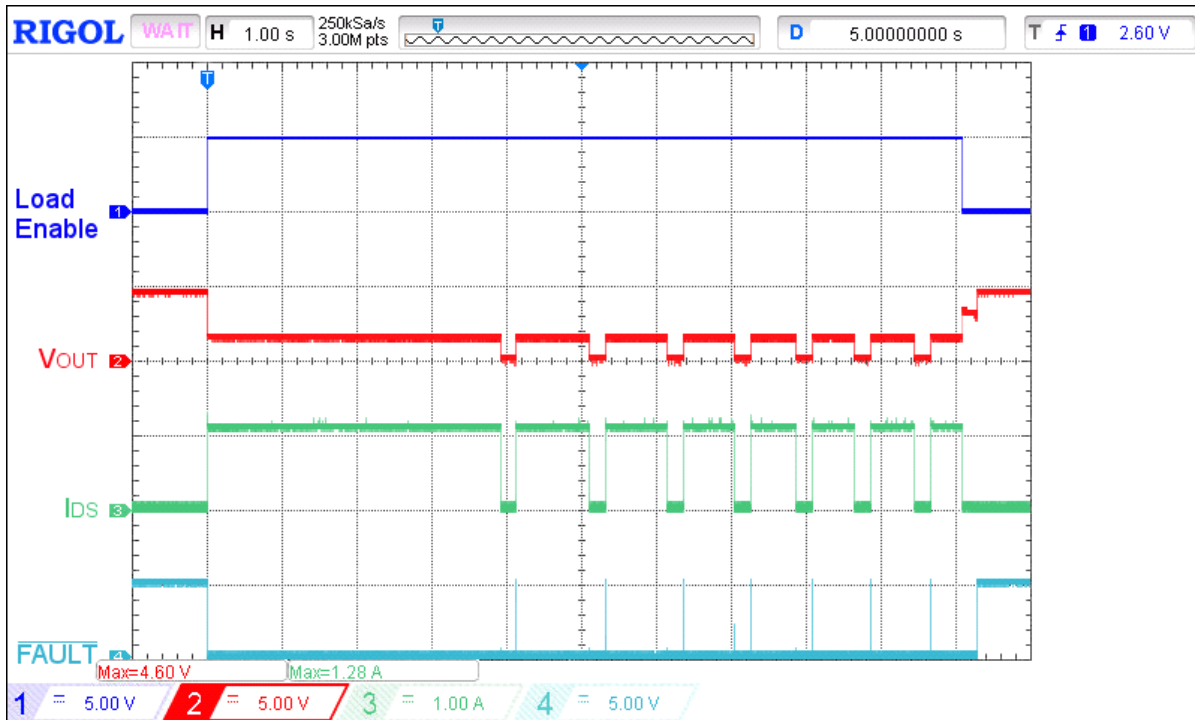


Figure 18. Typical ACL operation waveform for $V_{IN} = 4.5\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$

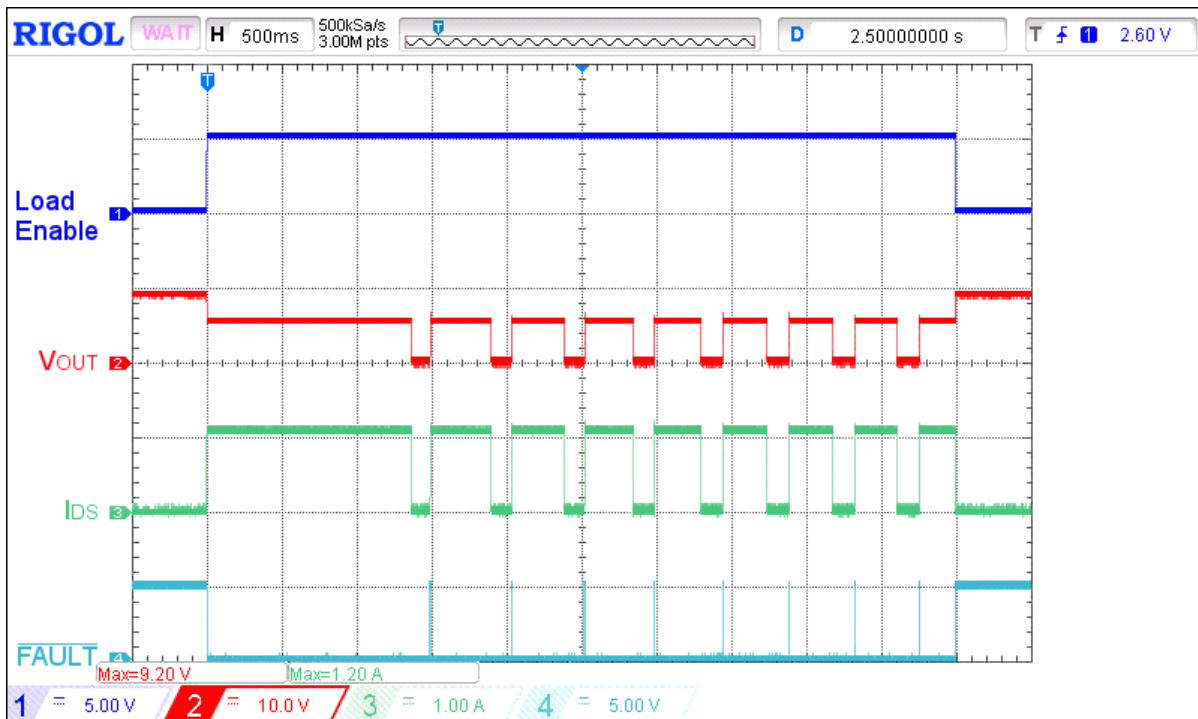


Figure 19. Typical ACL operation waveform for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

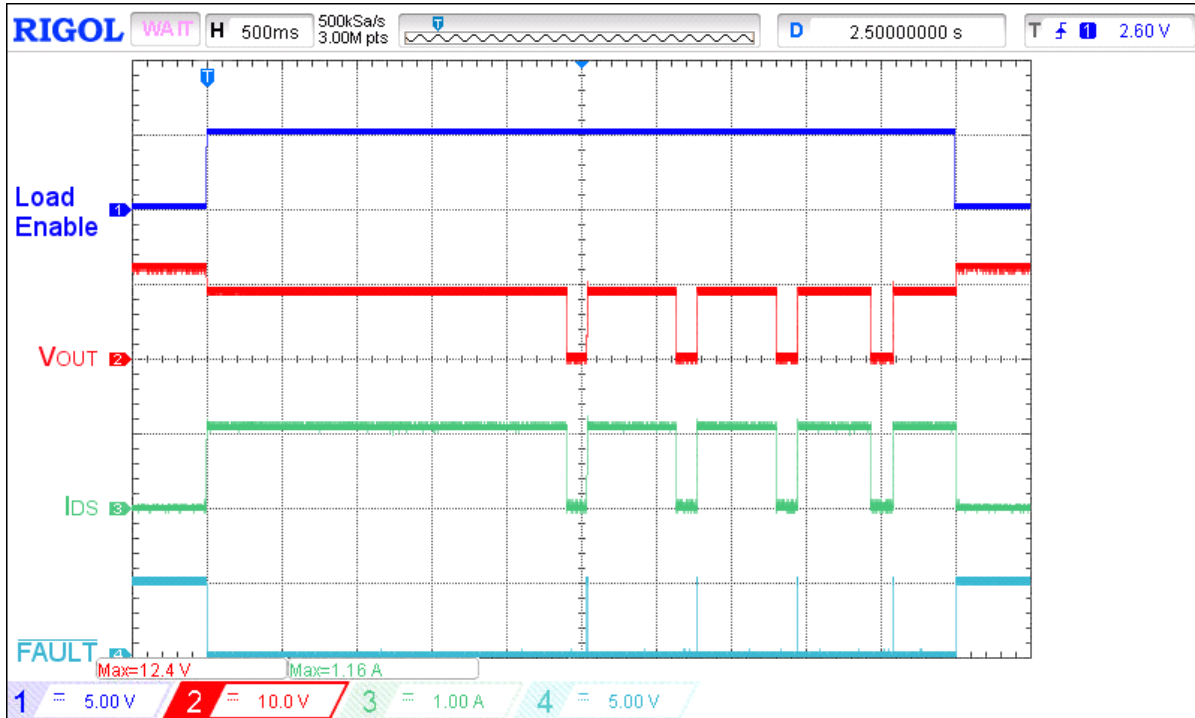


Figure 20. Typical ACL operation waveform for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$

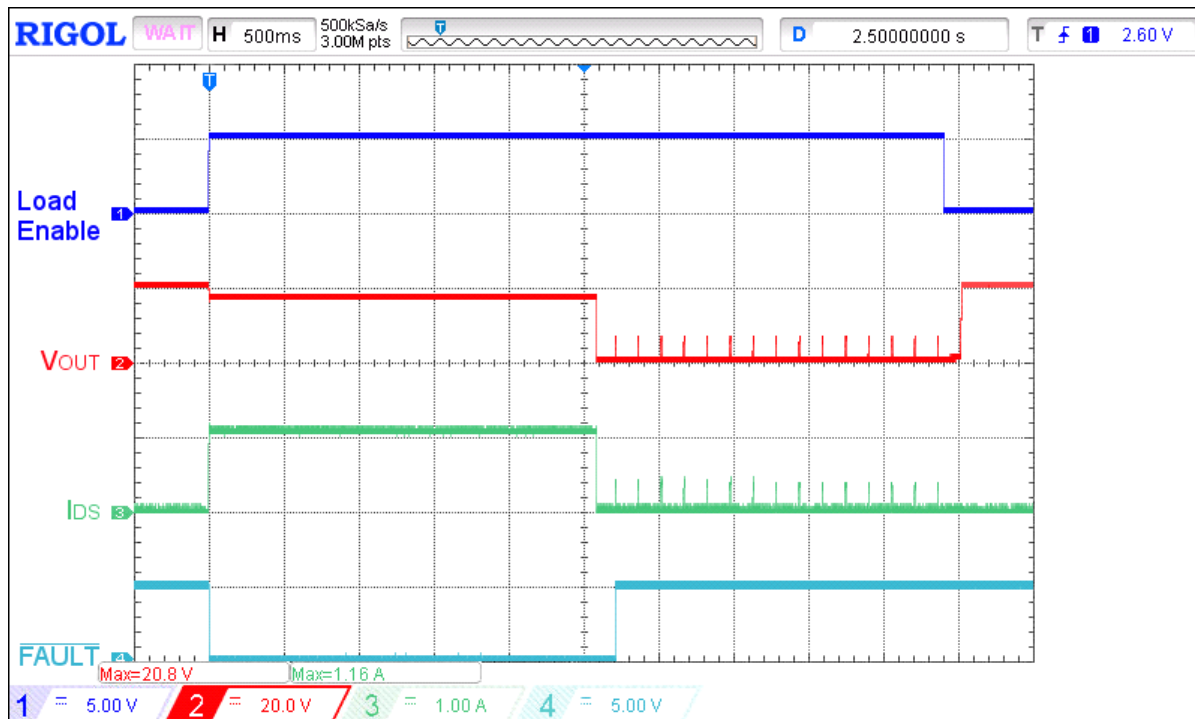


Figure 21. Typical ACL operation waveform for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

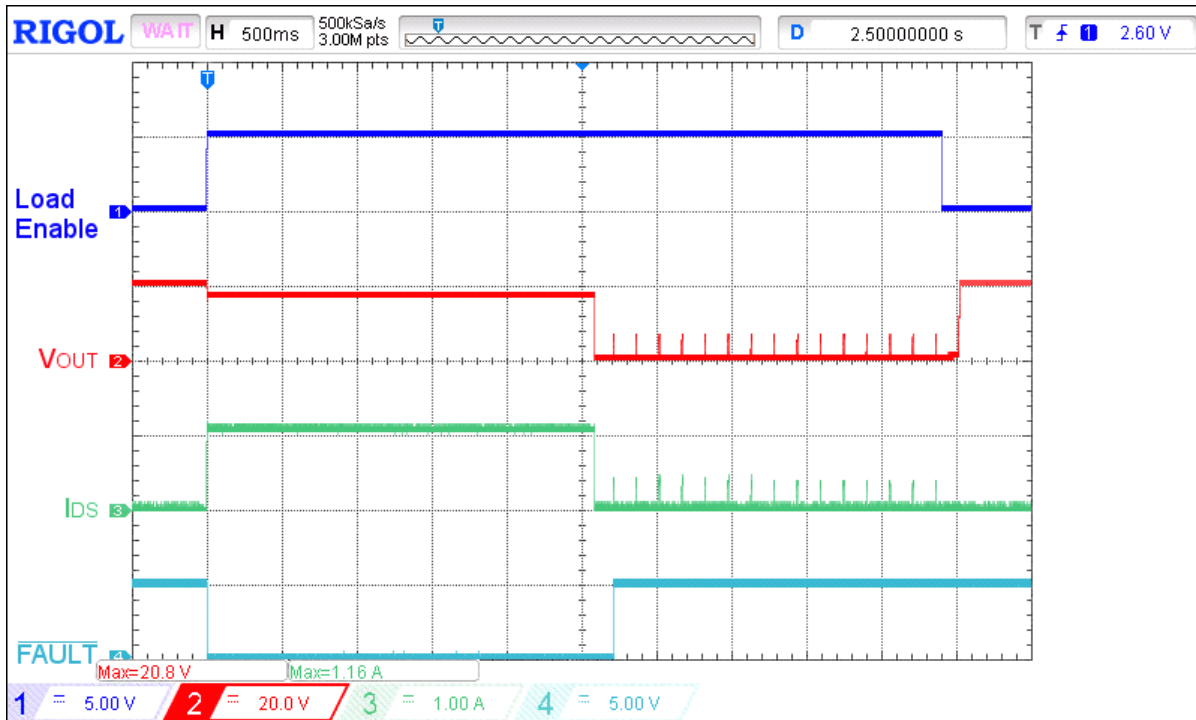


Figure 22. Thermally induced SOA shutdown for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Typical FAULT Operation Waveforms

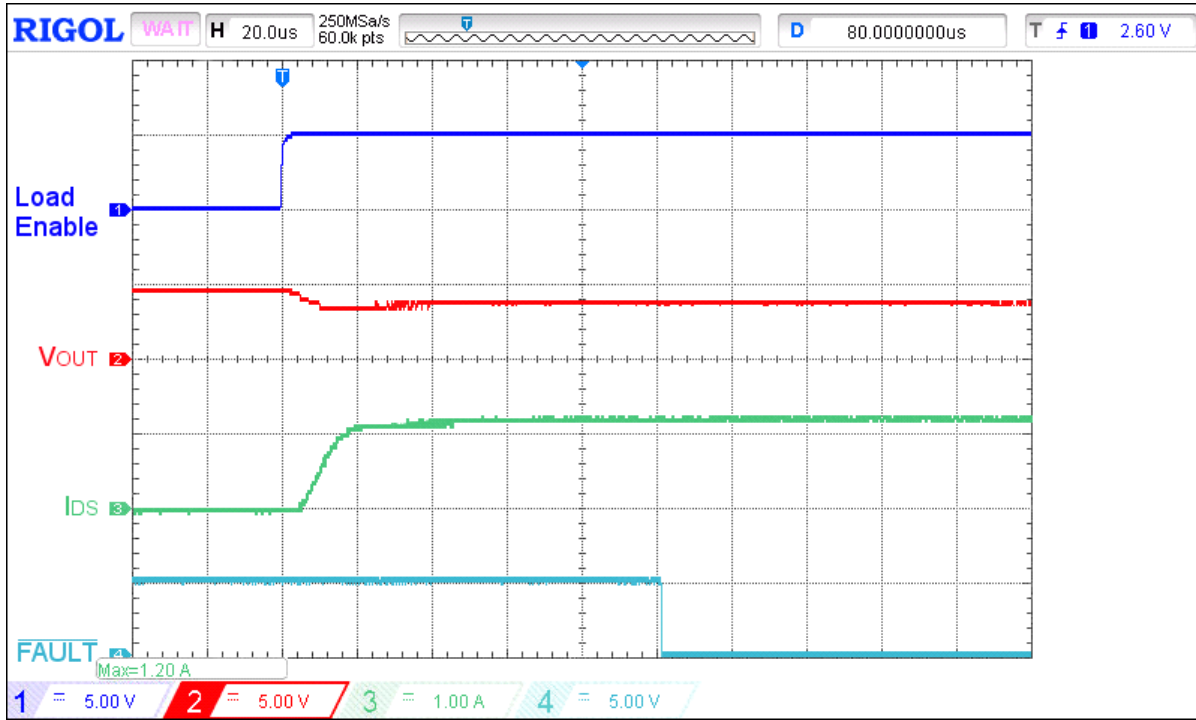


Figure 23. Typical FAULT assertion waveform for $V_{IN} = 4.5\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$, switch on $3.8\ \Omega$ load

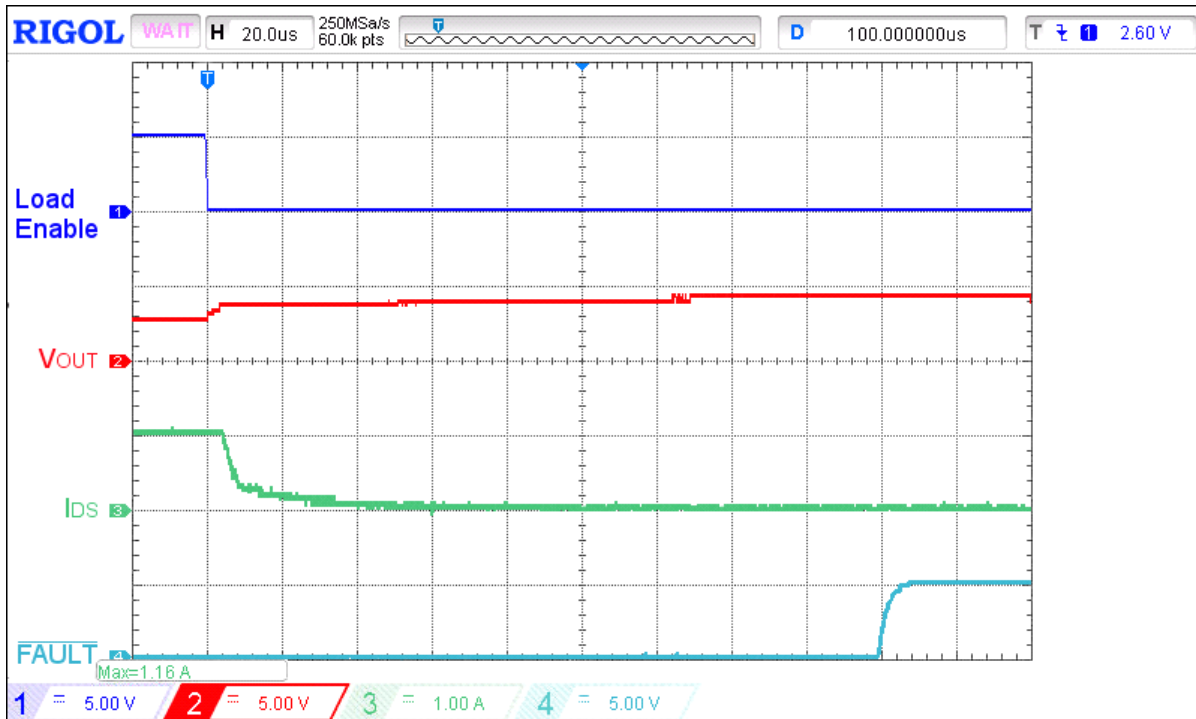


Figure 24. Typical FAULT de-assertion waveform for $V_{IN} = 4.5\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\text{ A}$, $R_{SET} = 91\text{ k}\Omega$, switch out $3.8\ \Omega$ load

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

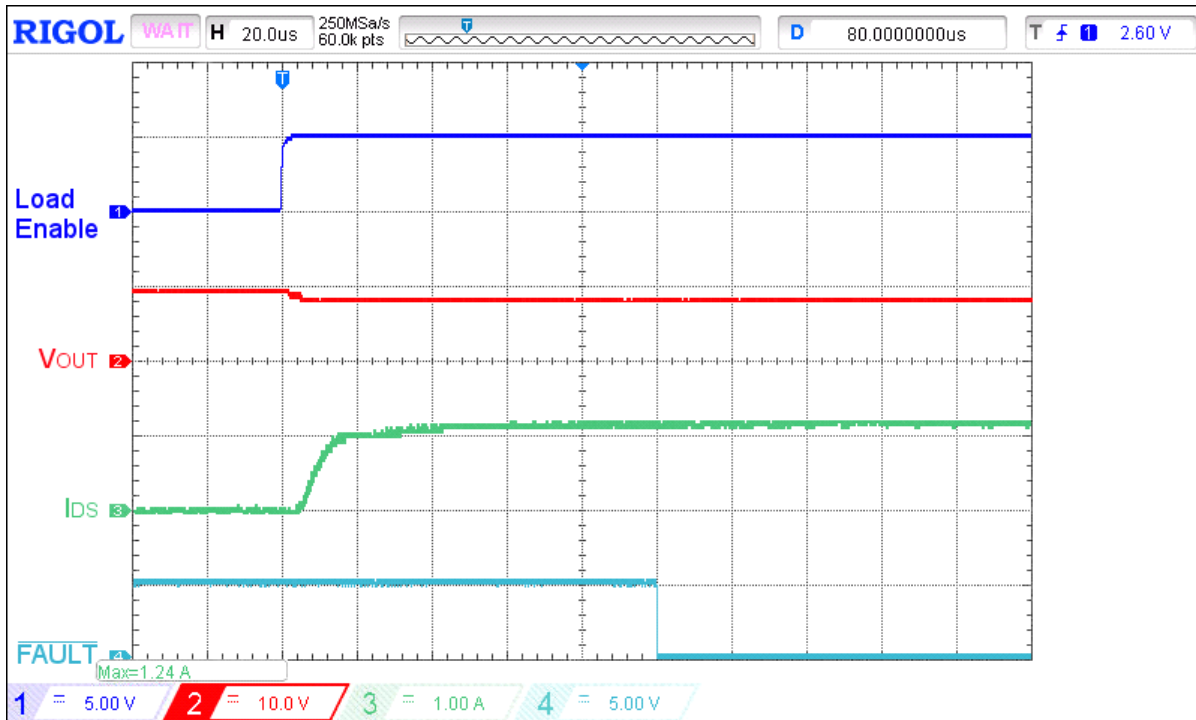


Figure 25. Typical FAULT assertion waveform for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\ \text{A}$, $R_{SET} = 91\ \text{k}\Omega$, switch on $6.7\ \Omega$ load

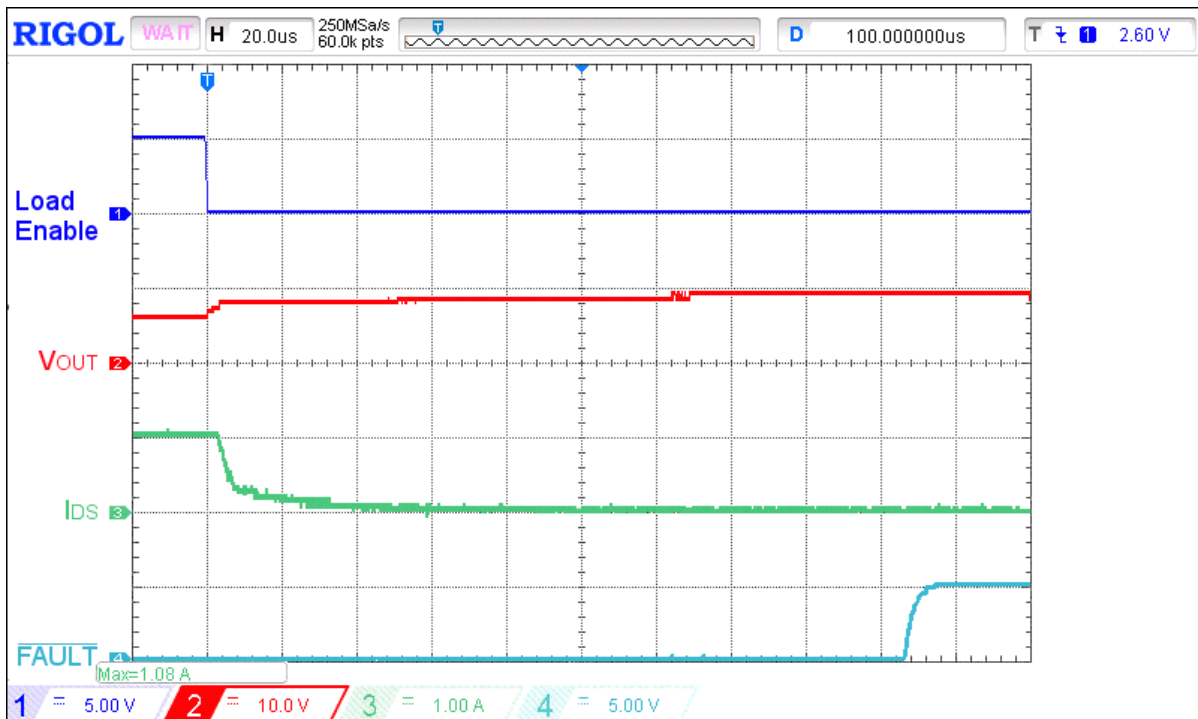


Figure 26. Typical FAULT de-assertion waveform for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\ \text{A}$, $R_{SET} = 91\ \text{k}\Omega$, switch out $6.7\ \Omega$ load

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

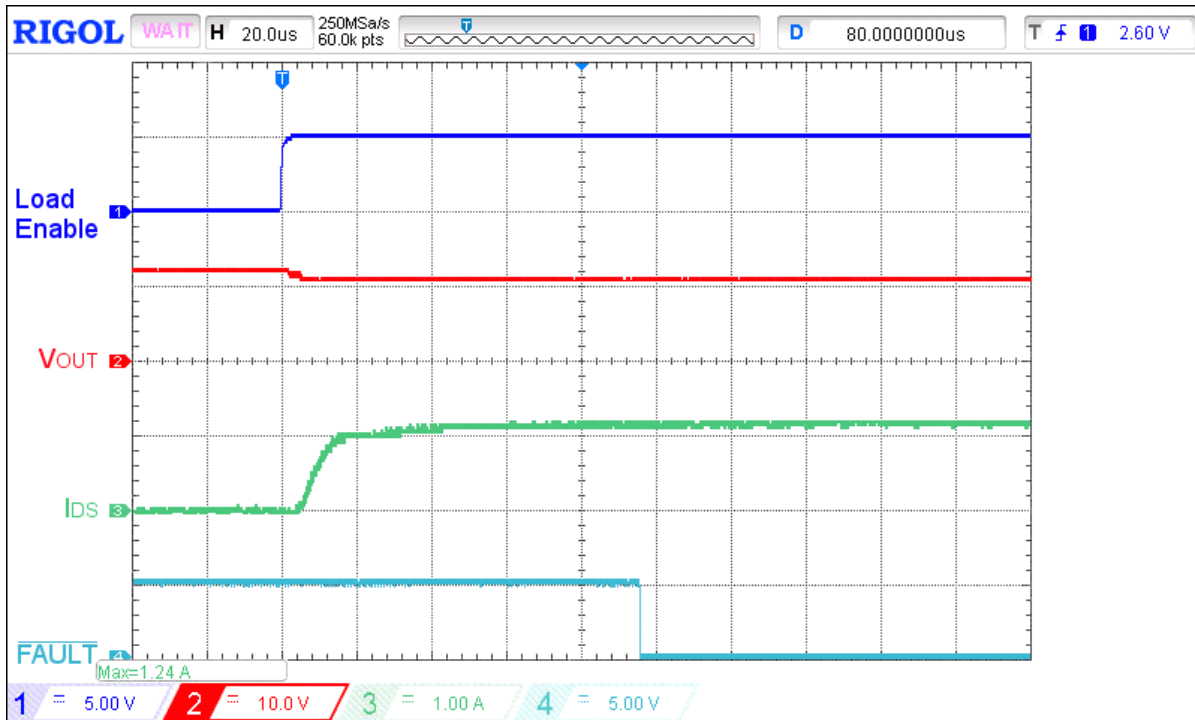


Figure 27. Typical FAULT assertion waveform for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\ \text{A}$, $R_{SET} = 91\ \text{k}\Omega$, switch on $9\ \Omega$ load

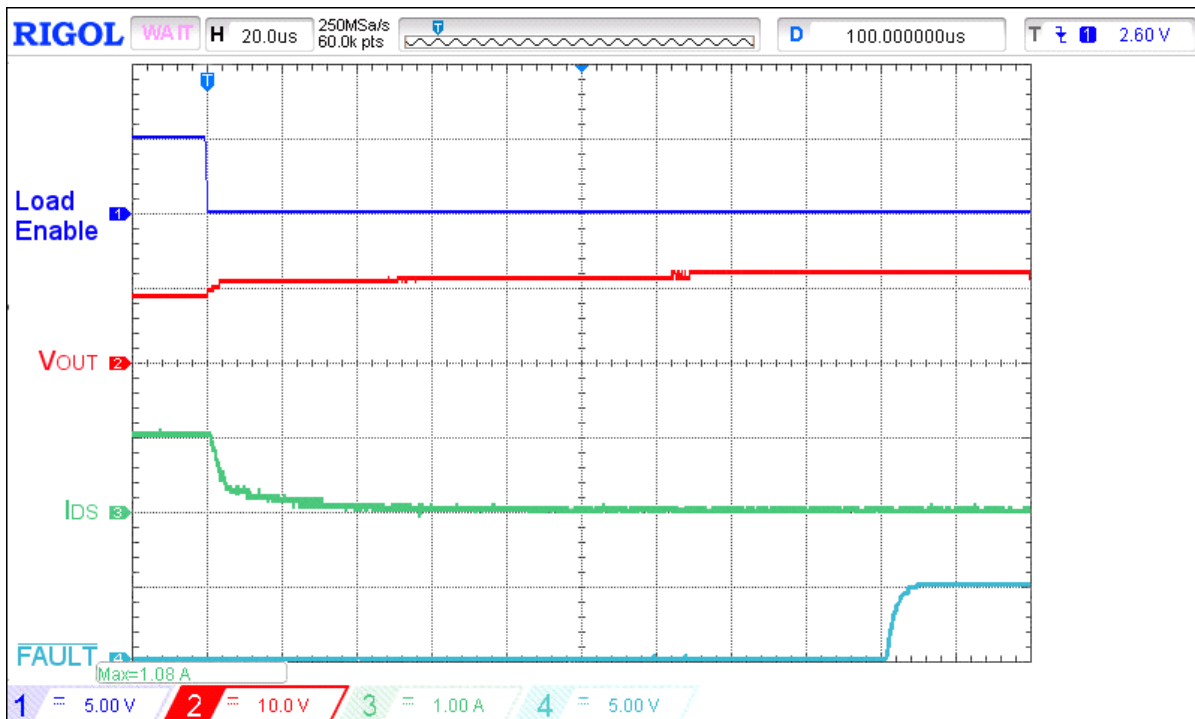


Figure 28. Typical FAULT de-assertion waveform for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\ \text{A}$, $R_{SET} = 91\ \text{k}\Omega$, switch out $9\ \Omega$ load

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

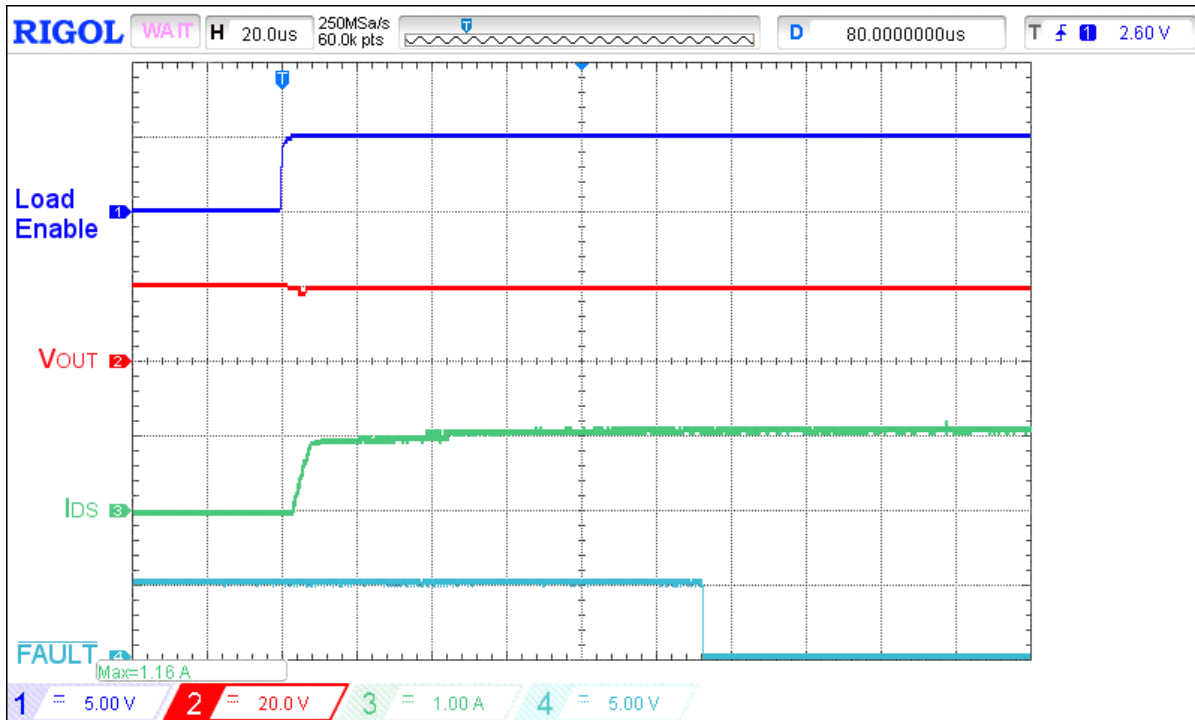


Figure 29. Typical FAULT assertion waveform for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\ \text{A}$, $R_{SET} = 91\ \text{k}\Omega$, switch on $15\ \Omega$ load

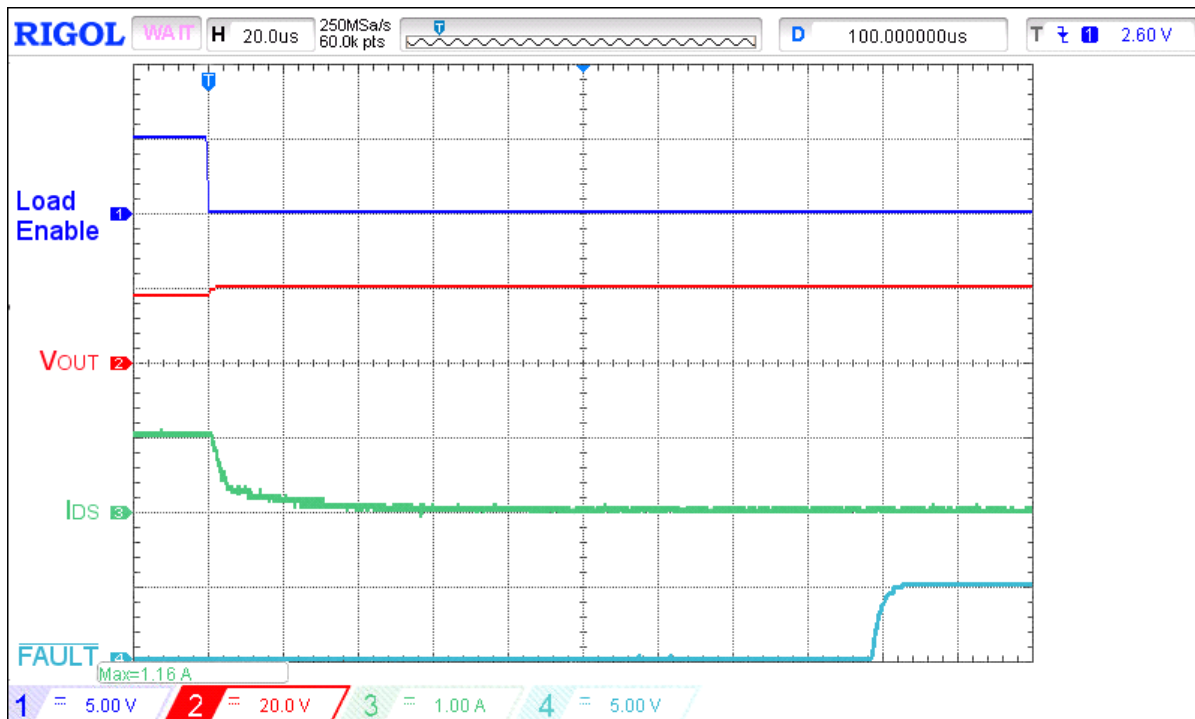


Figure 30. Typical FAULT de-assertion waveform for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $I_{ACL} = 1\ \text{A}$, $R_{SET} = 91\ \text{k}\Omega$, switch out $15\ \Omega$ load

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Typical I_{OUT} Response Time Waveforms

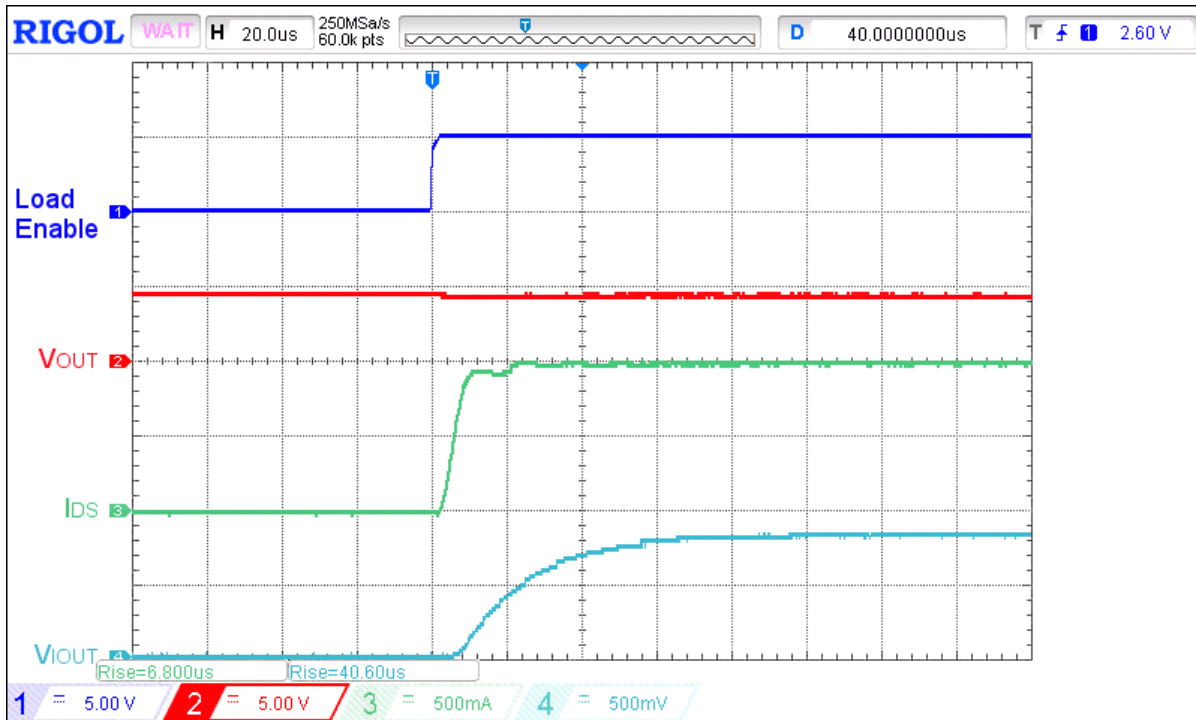


Figure 31. Typical I_{OUT} response time waveform for $V_{IN} = 4.5\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 4.5\ \Omega$, $C_{IOUT} = 0.18\ \text{nF}$, $R_{IOUT} = 84.5\ \text{k}\Omega$, load step 0 A to 1 A

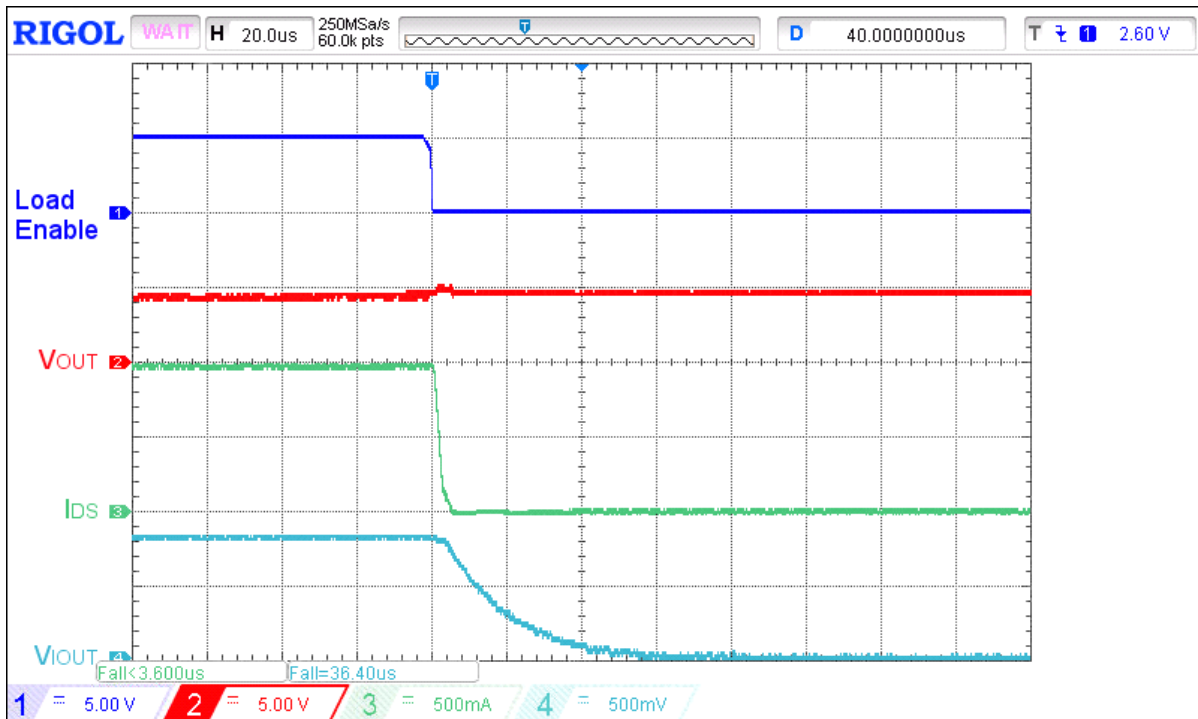


Figure 32. Typical I_{OUT} response time waveform for $V_{IN} = 4.5\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 4.5\ \Omega$, $C_{IOUT} = 0.18\ \text{nF}$, $R_{IOUT} = 84.5\ \text{k}\Omega$, load step 1 A to 0 A

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

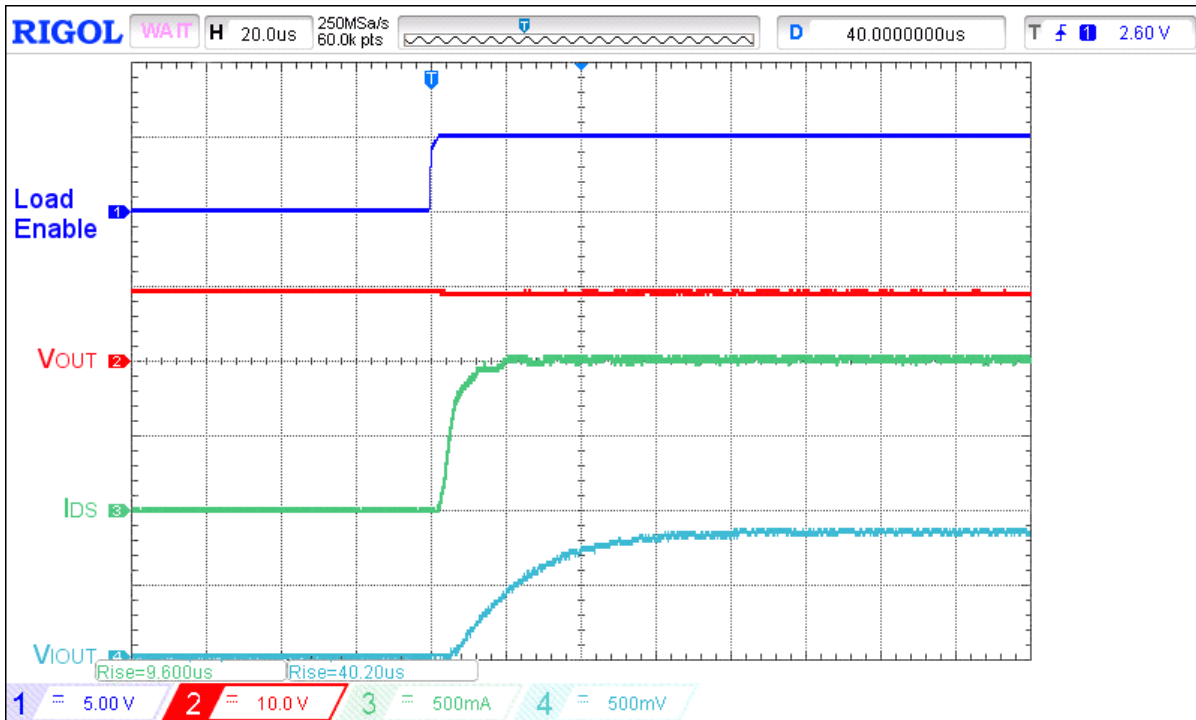


Figure 33. Typical I_{OUT} response time waveform for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 9\text{ }\Omega$, $C_{IOUT} = 0.18\text{ nF}$, $R_{IOUT} = 84.5\text{ k}\Omega$, load step 0 A to 1 A

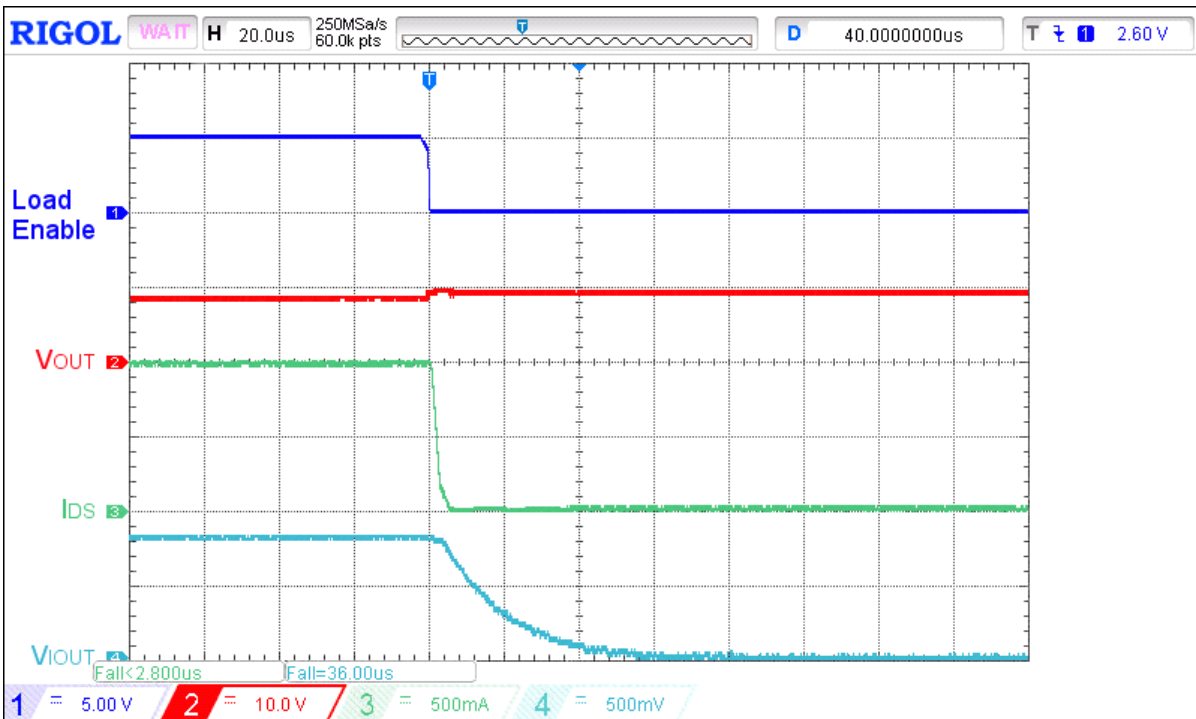


Figure 34. Typical I_{OUT} response time waveform for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 9\text{ }\Omega$, $C_{IOUT} = 0.18\text{ nF}$, $R_{IOUT} = 84.5\text{ k}\Omega$, load step 1 A to 0 A

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

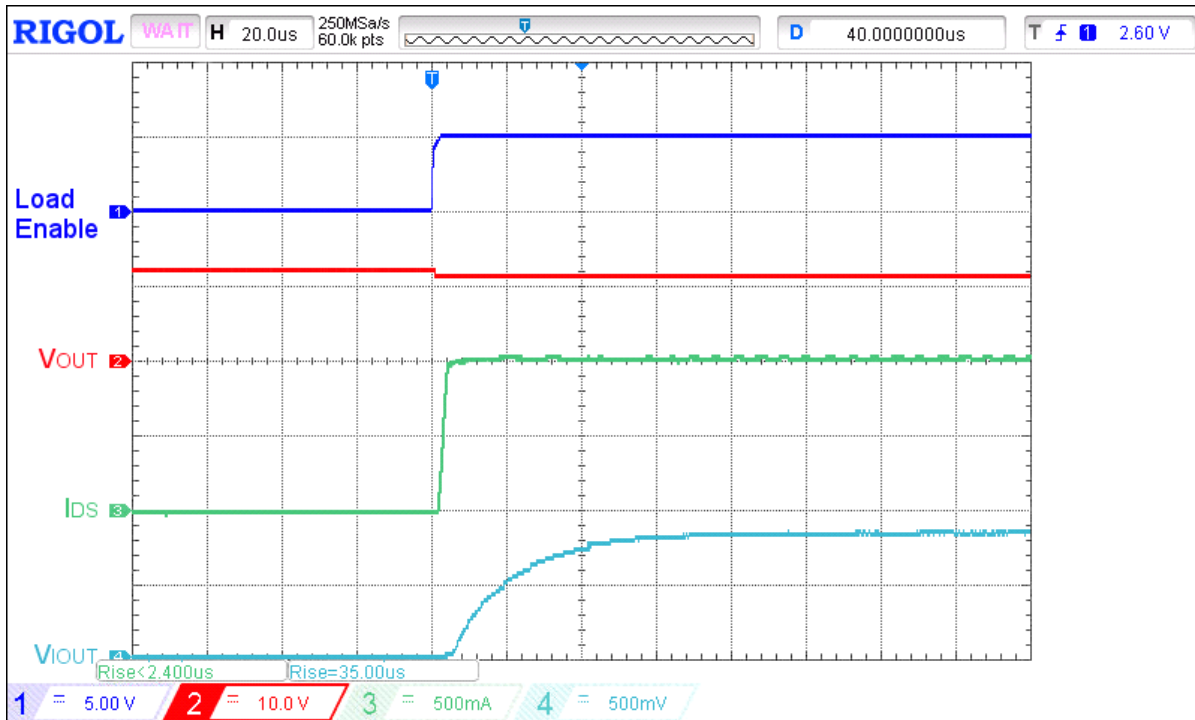


Figure 35. Typical I_{OUT} response time waveform for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 12\text{ }\Omega$, $C_{IOUT} = 0.18\text{ nF}$, $R_{IOUT} = 84.5\text{ k}\Omega$, load step 0 A to 1 A

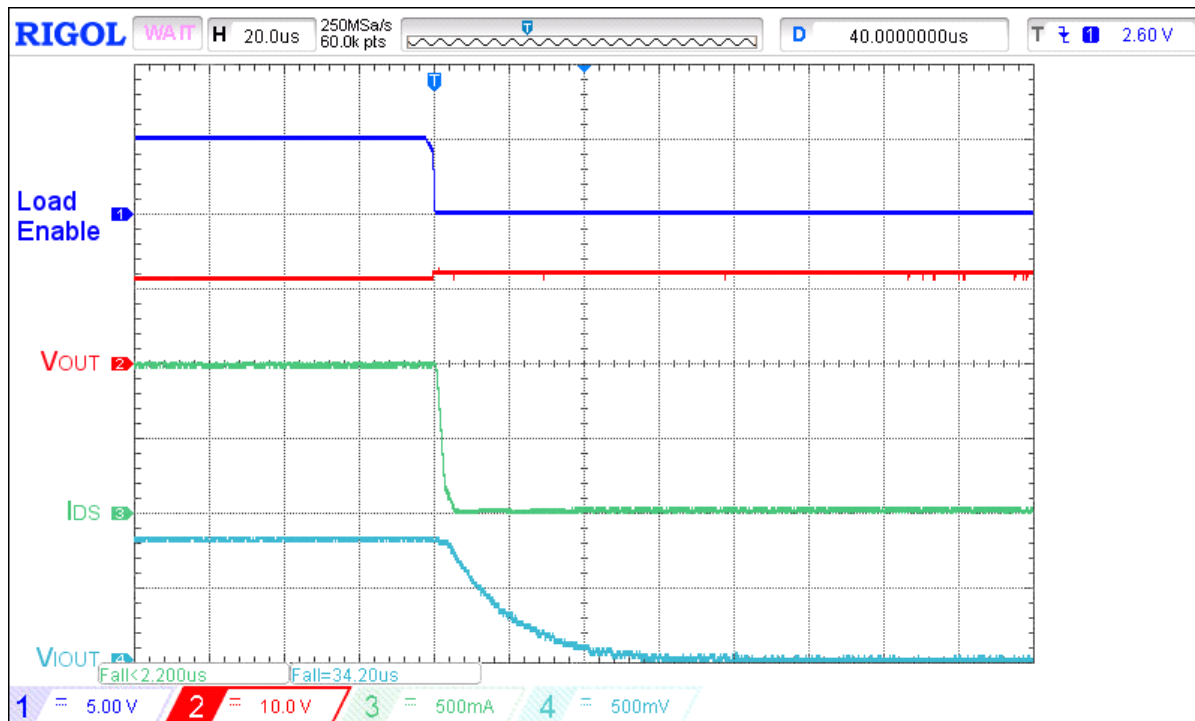


Figure 36. Typical I_{OUT} response time waveform for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\text{ }\mu\text{F}$, $R_{LOAD} = 12\text{ }\Omega$, $C_{IOUT} = 0.18\text{ nF}$, $R_{IOUT} = 84.5\text{ k}\Omega$, load step 1 A to 0 A

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

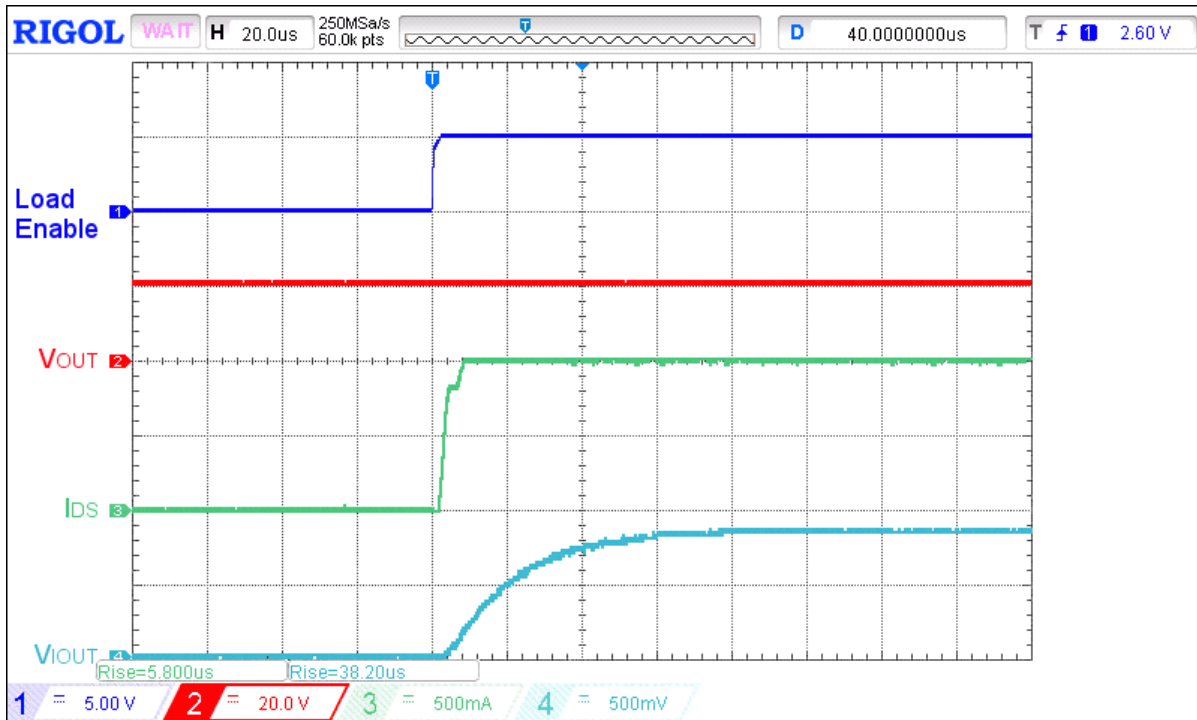


Figure 37. Typical I_{OUT} response time waveform for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 20\ \Omega$, $C_{IOUT} = 0.18\ \text{nF}$, $R_{IOUT} = 84.5\ \text{k}\Omega$, load step 0 A to 1 A

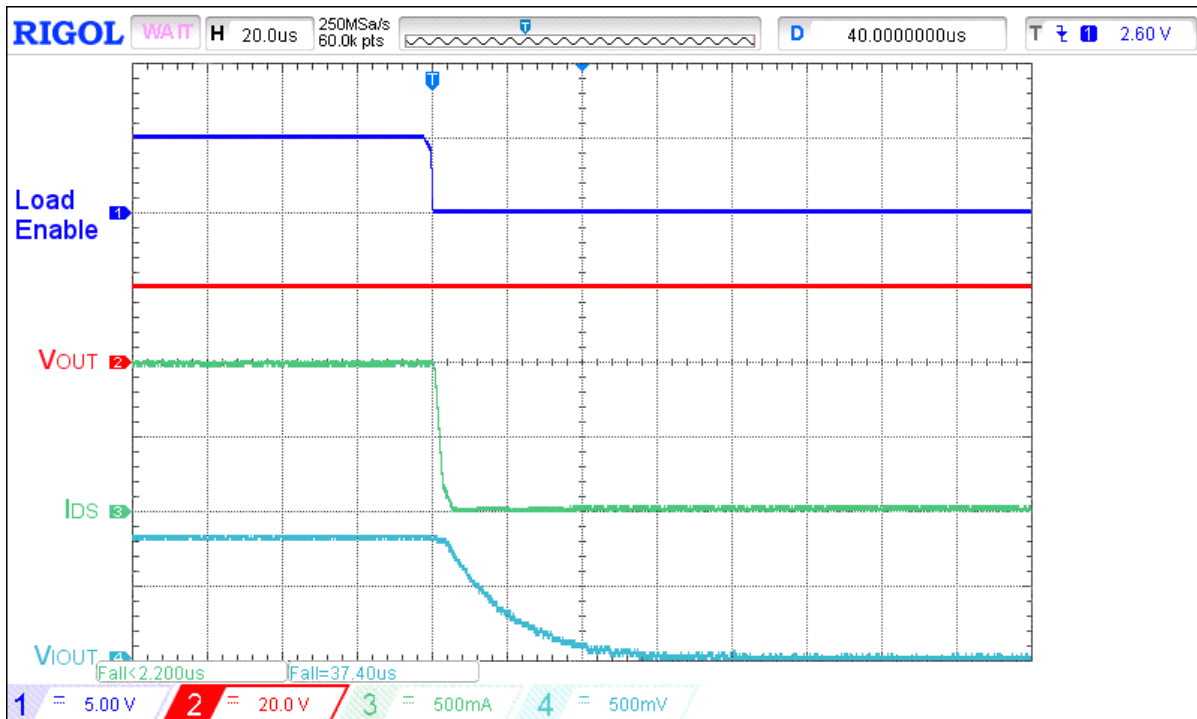


Figure 38. Typical I_{OUT} response time waveform for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{LOAD} = 20\ \Omega$, $C_{IOUT} = 0.18\ \text{nF}$, $R_{IOUT} = 84.5\ \text{k}\Omega$, load step 1 A to 0 A

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Typical SOA Waveforms

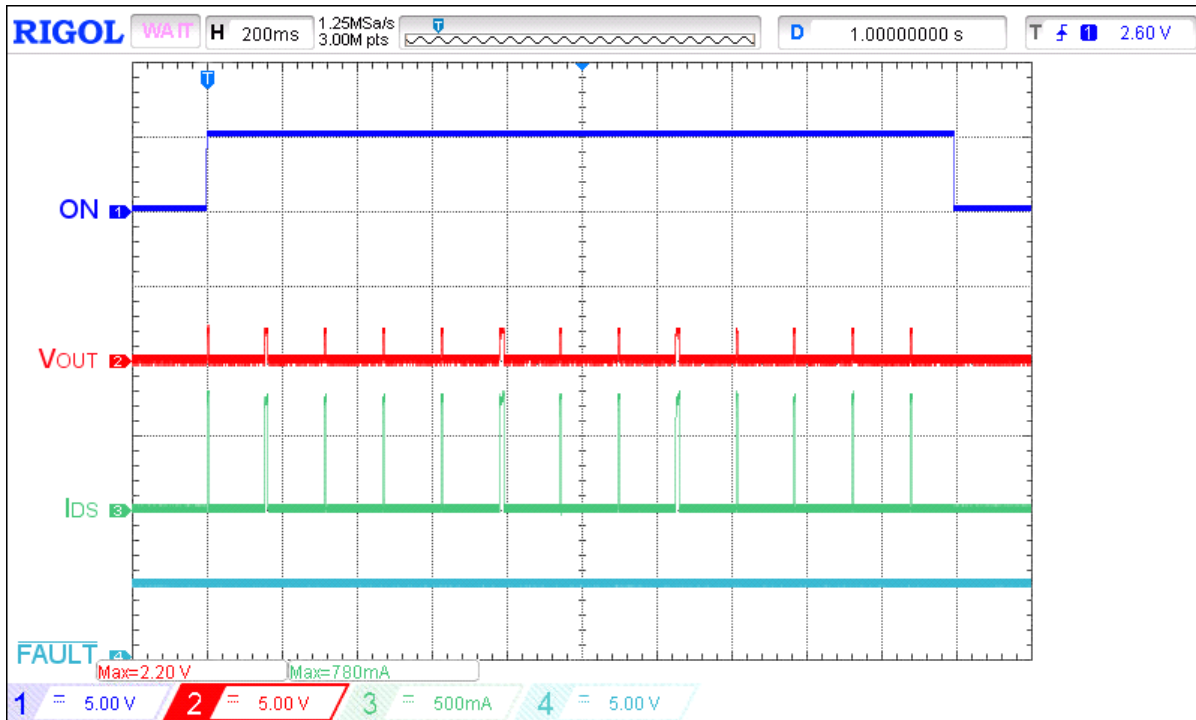


Figure 39. Typical SOA waveform during power up under heavy load for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{SET} = 30.1\ \text{k}\Omega$, $R_{LOAD} = 3.8\ \Omega$

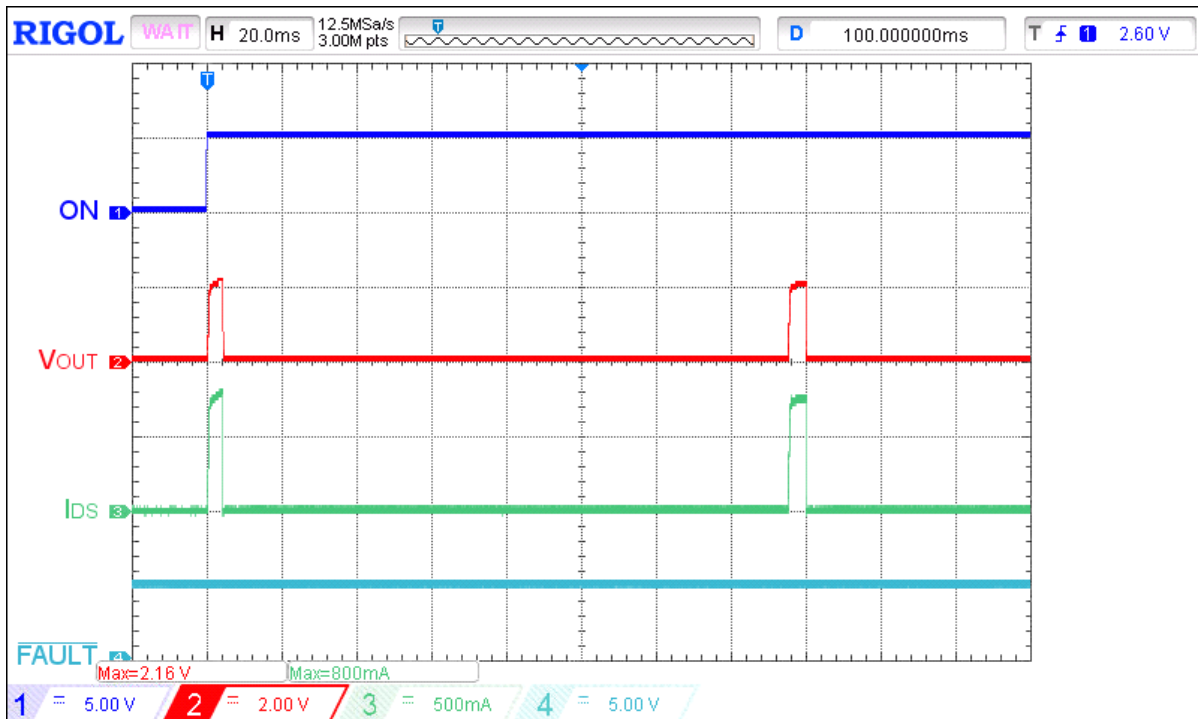


Figure 40. Extended typical SOA waveform during power up under heavy load for $V_{IN} = 9\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{SET} = 30.1\ \text{k}\Omega$, $R_{LOAD} = 3.8\ \Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

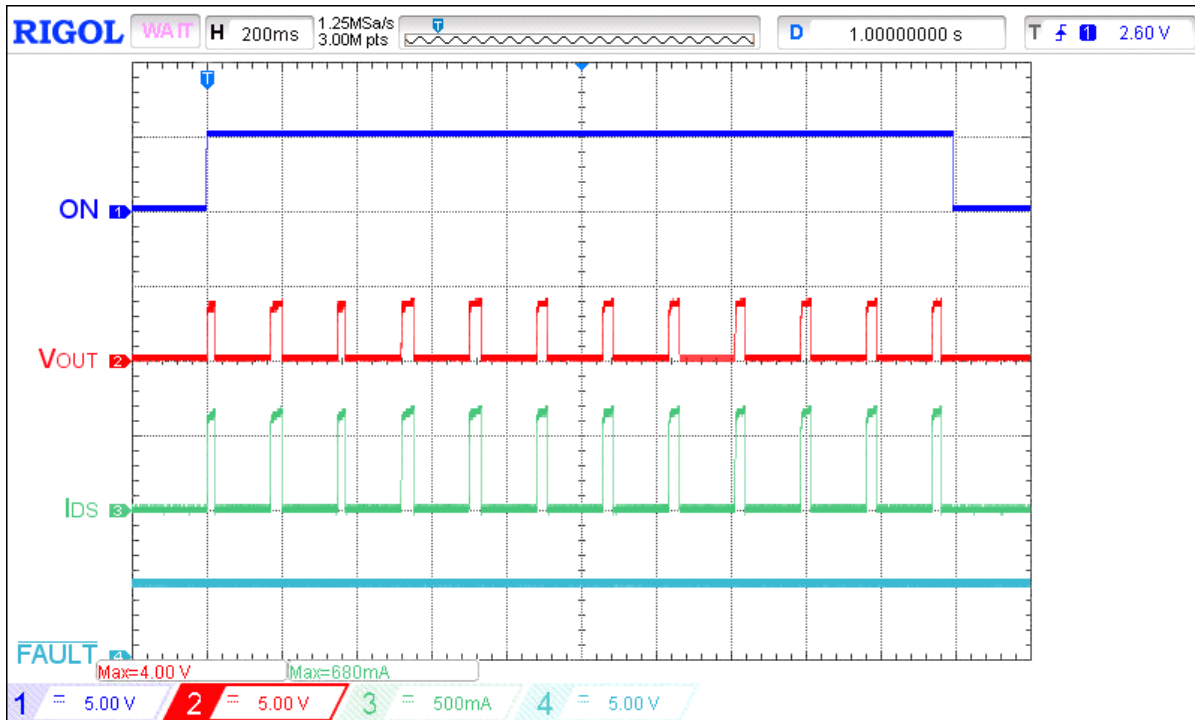


Figure 41. Typical SOA waveform during power up under heavy load for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{SET} = 30.1\ \text{k}\Omega$, $R_{LOAD} = 5\ \Omega$

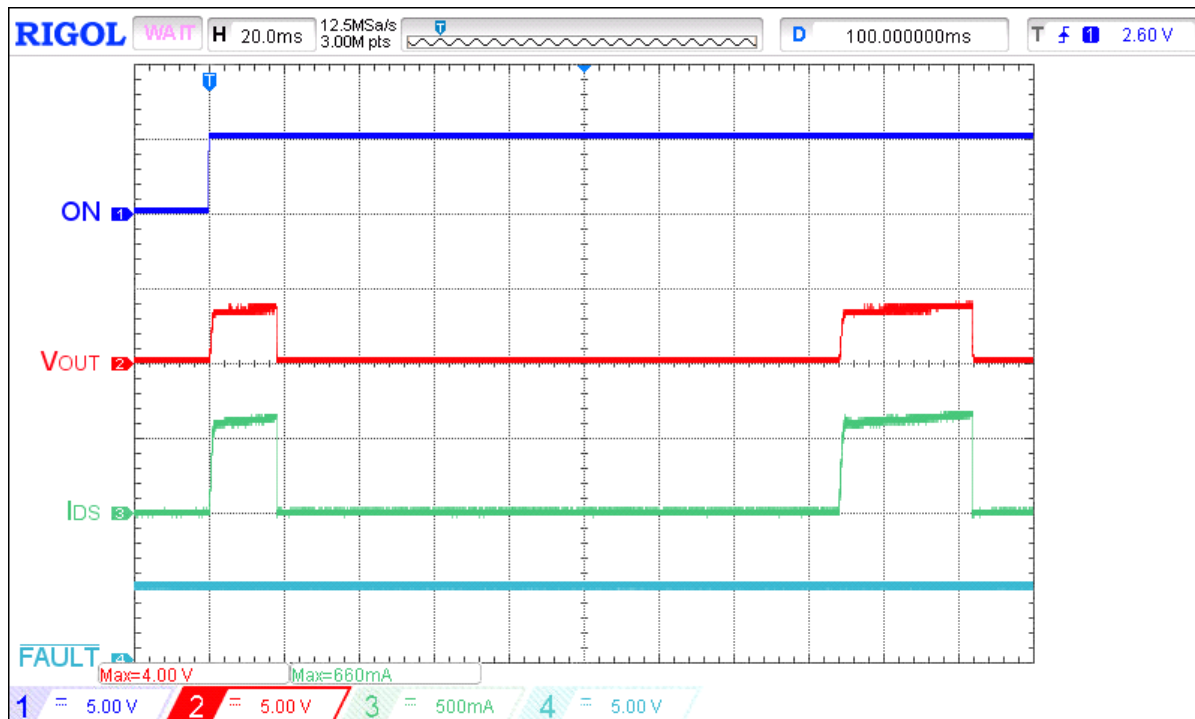


Figure 42. Extended typical SOA waveform during power up under heavy load for $V_{IN} = 12\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{SET} = 30.1\ \text{k}\Omega$, $R_{LOAD} = 5\ \Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

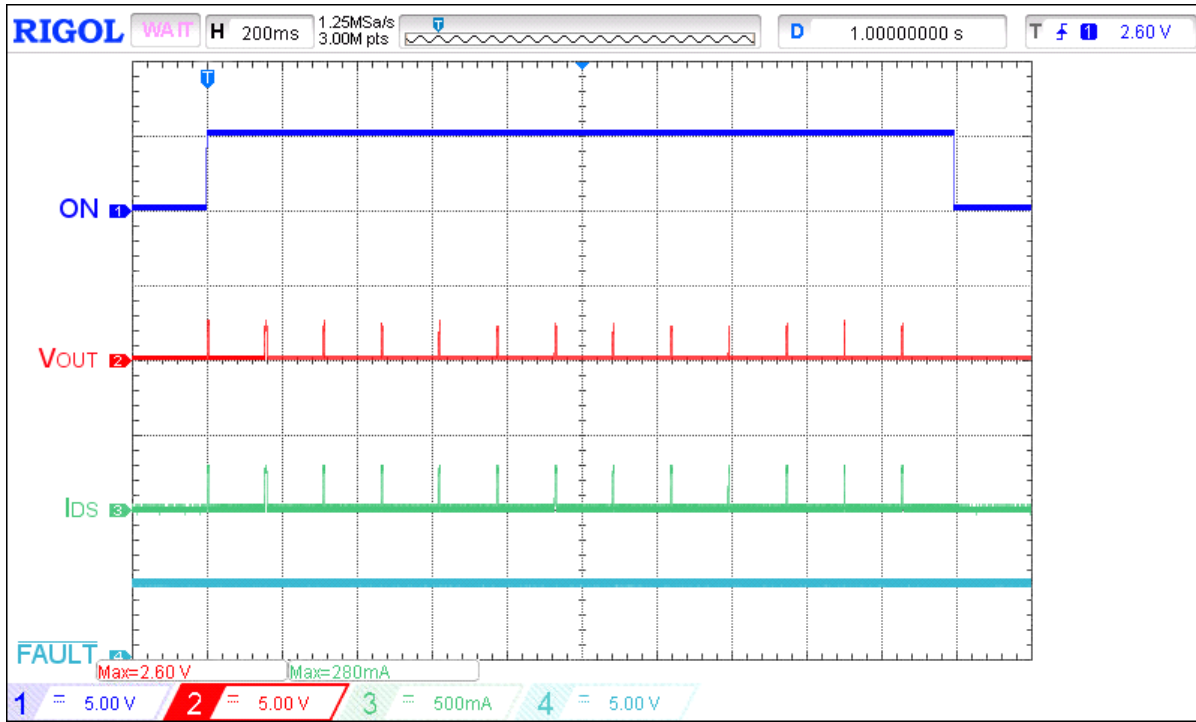


Figure 43. Typical SOA waveform during power up under heavy load for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{SET} = 30.1\ \text{k}\Omega$, $R_{LOAD} = 8\ \Omega$

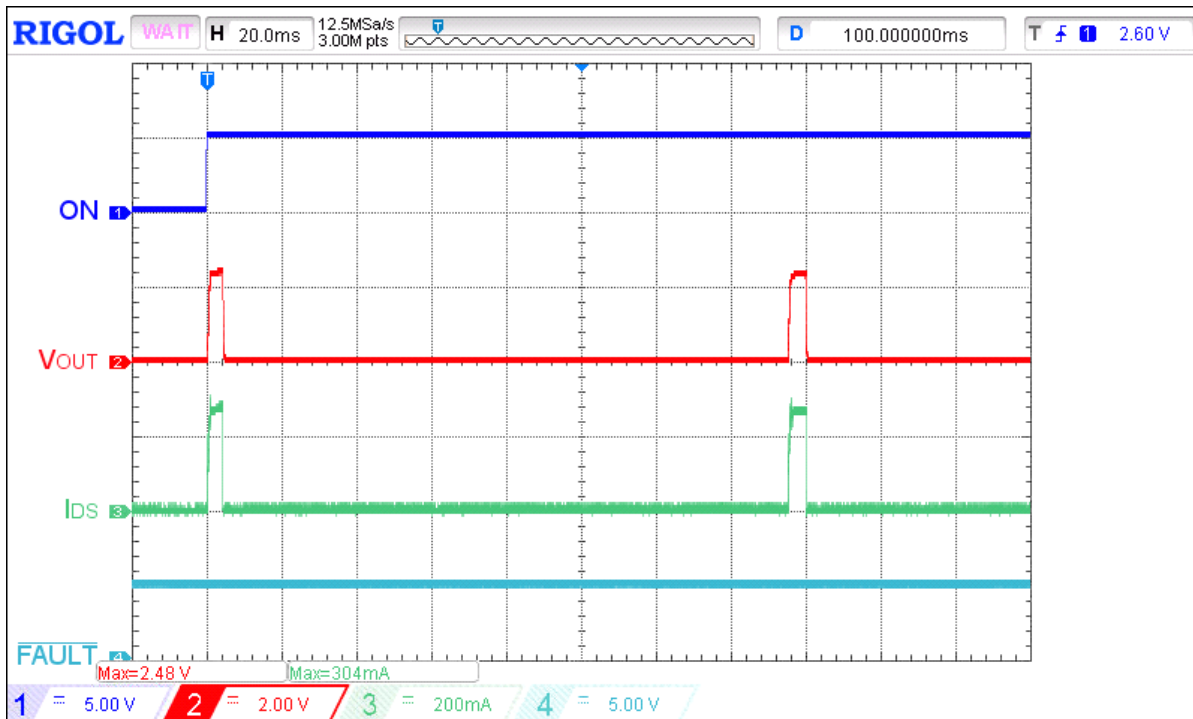


Figure 44. Extended typical SOA waveform during power up under heavy load for $V_{IN} = 20\text{ V}$, $C_{LOAD} = 10\ \mu\text{F}$, $R_{SET} = 30.1\ \text{k}\Omega$, $R_{LOAD} = 8\ \Omega$

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Applications Information

HFET1 Safe Operating Area Explained

Dialog’s HFET1 integrated power controllers incorporate a number of internal protection features that prevents them from damaging themselves or any other circuit or subcircuit downstream of them. One particular protection feature is their Safe Operation Area (SOA) protection. SOA protection is automatically activated under overpower and, in some cases, under overcurrent conditions. Overpower SOA is activated if package power dissipation exceeds an internal 5 W threshold longer than 2.5 ms. HFET1 devices will quickly switch off (open circuit) upon overpower detection and automatically resume (close) nominal operation once overpower condition no longer exists.

One possible way to have an overpower condition trigger SOA protection is when HFET1 products are enabled into heavy output resistive loads and/or into large load capacitors. It is under these conditions to follow carefully the “Safe Start-up Loading” guidance in the Applications section of the datasheet. During an overcurrent condition, HFET1 devices will try to limit the output current to the level set by the external R_{SET} resistor. Limiting the output current, however, causes an increased voltage drop across the FET’s channel because the FET’s R_{DS(ON)} increased as well. Since the FET’s R_{DS(ON)} is larger, package power dissipation also increases. If the resultant increase in package power dissipation is higher/equal than 5 W for longer than 2.5 ms, internal SOA protection will be triggered and the FET will open circuit (switch off). Every time SOA protection is triggered, all HFET1 devices will automatically attempt to resume nominal operation after 160 ms.

Safe Start-up Condition

SLG59H1020V has built-in protection to prevent over-heating during start-up into a heavy load. Overloading the V_{OUT} pin with a capacitor and a resistor may result in non-monotonic V_{OUT} ramping. In general, under light loading on V_{OUT}, V_{OUT} ramping can be controlled with C_{SLEW} value. The following equation serves as a guide:

$$C_{SLEW} = \frac{T_{RISE}}{V_{IN}} \times 4.9 \mu A \times \frac{20}{3}$$

where

T_{RISE} = Total rise time from 10% V_{OUT} to 90% V_{OUT}

V_{IN} = Input Voltage

C_{SLEW} = Capacitor value for CAP pin

When capacitor and resistor loading on V_{OUT} during start up, the following tables will ensure V_{OUT} ramping is monotonic without triggering internal protection:

Safe Start-up Loading for V _{IN} = 12 V (Monotonic Ramp)			
Slew Rate (V/ms)	C _{SLEW} (nF) ²	C _{LOAD} (μF)	R _{LOAD} (Ω)
1	33.3	500	20
2	16.7	250	20
3	11.1	160	20
4	8.3	120	20
5	6.7	100	20

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Safe Start-up Loading for $V_{IN} = 22\text{ V}$ (Monotonic Ramp)			
Slew Rate (V/ms)	C_{SLEW} (nF) ²	C_{LOAD} (μF)	R_{LOAD} (Ω)
0.5	66.7	500	80
1.0	33.3	250	80
1.5	22.2	160	80
2.0	16.7	120	80
2.5	13.3	100	80

Note 2: Select the closest-value tolerance capacitor.

Setting the SLG59H1020V's Active Current Limit

R_{SET} (kΩ)	Active Current Limit (A) ³
91	1
45	2
30	3

Note 3: Active Current Limit accuracy is ±15% over voltage range and over temperature range.

Setting the SLG59H1020V's Input Overvoltage Lockout Threshold

As shown in the table below, SEL[1,0] selects the V_{IN} overvoltage threshold at which the SLG59H1020V's internal state machine will turn OFF (open circuit) the power MOSFET if V_{IN} exceeds the selected threshold.

SEL1	SEL0	$V_{IN(OVLO)}$ (Typ)
0	0	6.0
0	1	10.8
1	0	17.0
1	1	22.0

For example, SEL[1,1] would be the most appropriate setting for applications where the steady-state V_{IN} can extend up to 20 V without causing any damage to the SLG59H1020V since the IC is 29-V tolerant.

With an activated SLG59H1020V (ON=HIGH) and at any time V_{IN} crosses the programmed V_{IN} overvoltage threshold, the state machine opens the power switch and asserts the FAULT pin within T_{FAULT_LOW} .

In applications with a deactivated or inactive SLG59H1020V ($V_{IN} > V_{IN(UVLO)}$ and ON=LOW) and if the applied V_{IN} is higher than the programmed $V_{IN(OVLO)}$ threshold, the SLG59H1020V's state machine will keep the power switch open circuited if the ON pin is toggled LOW-to-HIGH. In these cases, the FAULT pin will also be asserted within T_{FAULT_LOW} and will remain asserted until V_{IN} resumes nominal, steady-state operation.

In all cases, the SLG59H1020V's V_{IN} undervoltage lockout threshold is fixed at $V_{IN(UVLO)}$.

**A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output****Power Dissipation**

The junction temperature of the SLG59H1020V depends on different factors such as board layout, ambient temperature, and other environmental factors. The primary contributor to the increase in the junction temperature of the SLG59H1020V is the power dissipation of its power MOSFET. Its power dissipation and the junction temperature in nominal operating mode can be calculated using the following equations:

$$PD = RDS_{ON} \times I_{DS}^2$$

where:

PD = Power dissipation, in Watts (W)

RDS_{ON} = Power MOSFET ON resistance, in Ohms (Ω)

I_{DS} = Output current, in Amps (A)

and

$$T_J = PD \times \theta_{JA} + T_A$$

where:

T_J = Junction temperature, in Celsius degrees ($^{\circ}C$)

θ_{JA} = Package thermal resistance, in Celsius degrees per Watt ($^{\circ}C/W$)

T_A = Ambient temperature, in Celsius degrees ($^{\circ}C$)

In current-limit mode, the SLG59H1020V's power dissipation can be calculated by taking into account the voltage drop across the power switch ($V_{IN}-V_{OUT}$) and the magnitude of the output current in current-limit mode (I_{ACL}):

$$PD = (V_{IN}-V_{OUT}) \times I_{ACL} \text{ or}$$

$$PD = (V_{IN} - (R_{LOAD} \times I_{ACL})) \times I_{ACL}$$

where:

PD = Power dissipation, in Watts (W)

V_{IN} = Input Voltage, in Volts (V)

R_{LOAD} = Load Resistance, in Ohms (Ω)

I_{ACL} = Output limited current, in Amps (A)

$V_{OUT} = R_{LOAD} \times I_{ACL}$

SLG59H1020V

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Layout Guidelines:

1. Since the VIN and VOUT pins dissipate most of the heat generated during high-load current operation, it is highly recommended to make power traces as short, direct, and wide as possible. A good practice is to make power traces with absolute minimum widths of 15 mils (0.381 mm) per Ampere. A representative layout, shown in [Figure 45](#), illustrates proper techniques for heat to transfer as efficiently as possible out of the device;
2. To minimize the effects of parasitic trace inductance on normal operation, it is recommended to connect input C_{IN} and output C_{LOAD} low-ESR capacitors as close as possible to the SLG59H1020V's VIN and VOUT pins;
3. The GND pin should be connected to system analog or power ground plane.
4. 2 oz. copper is recommended for high current operation.

SLG59H1020V Evaluation Board:

A HFET1 Evaluation Board for SLG59H1020V is designed according to the statements above and is illustrated on [Figure 45](#). Please note that evaluation board has D_Sense and S_Sense pads. They cannot carry high currents and dedicated only for RDS_{ON} evaluation.

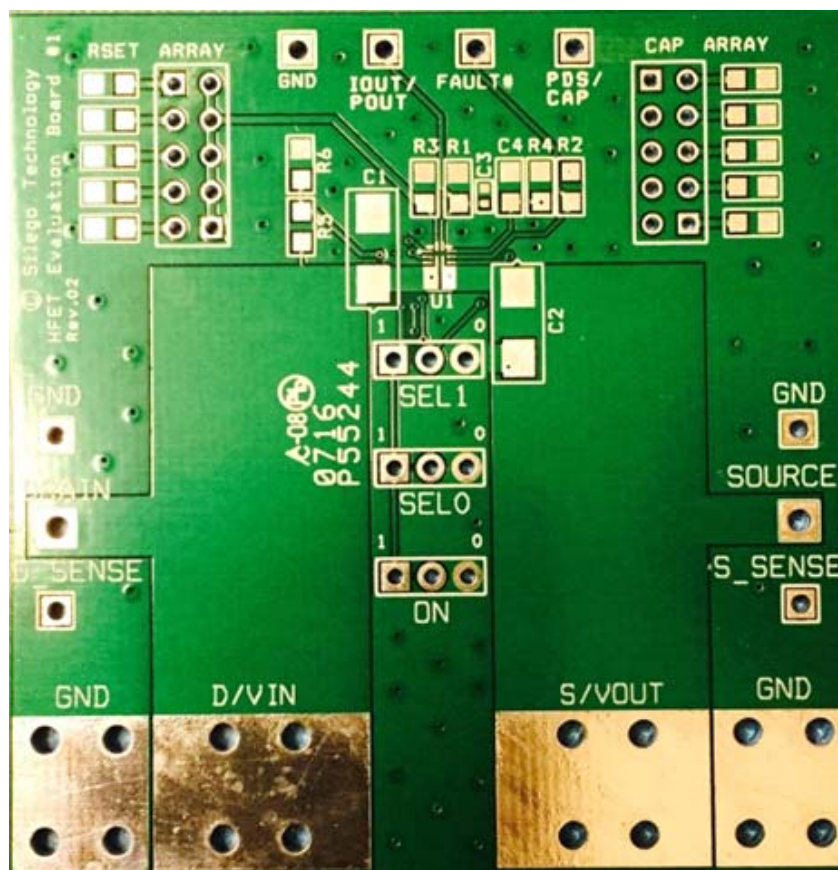


Figure 45. SLG59H1020V Evaluation Board

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

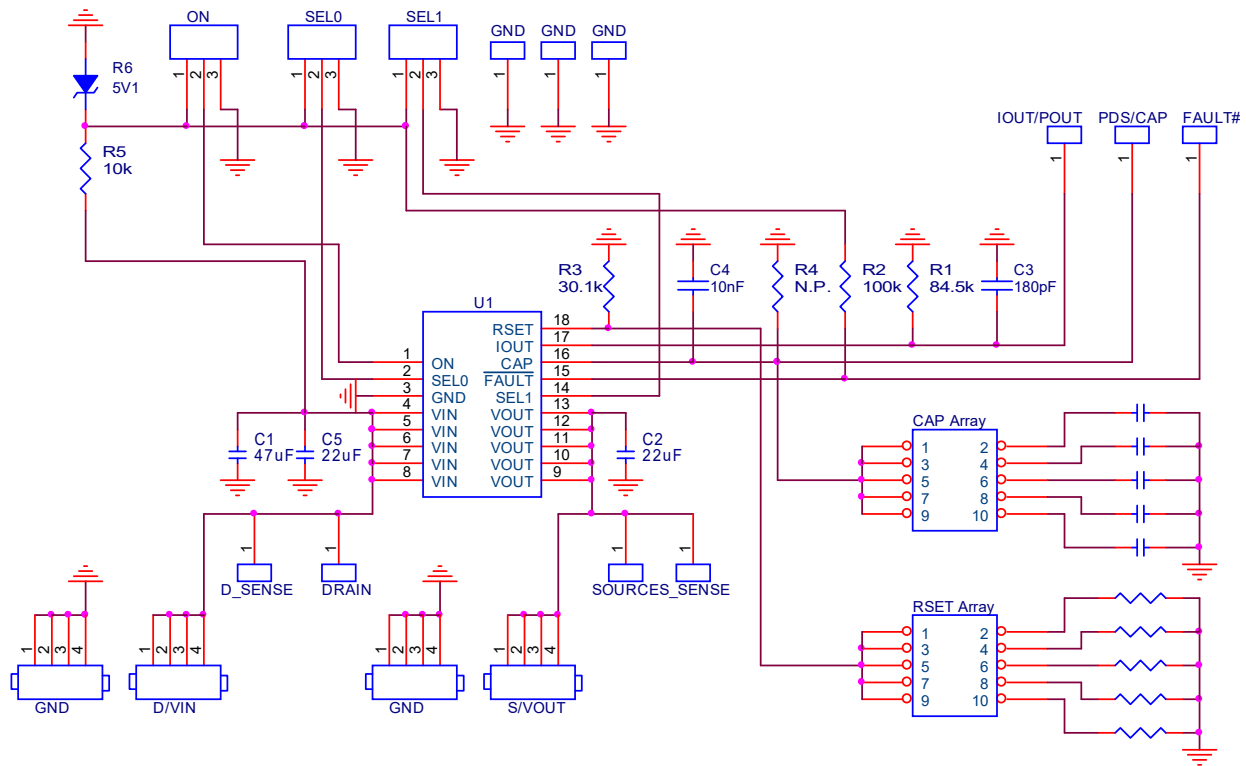


Figure 46. SLG59H1020V Evaluation Board Connection Circuit

Basic Test Setup and Connections

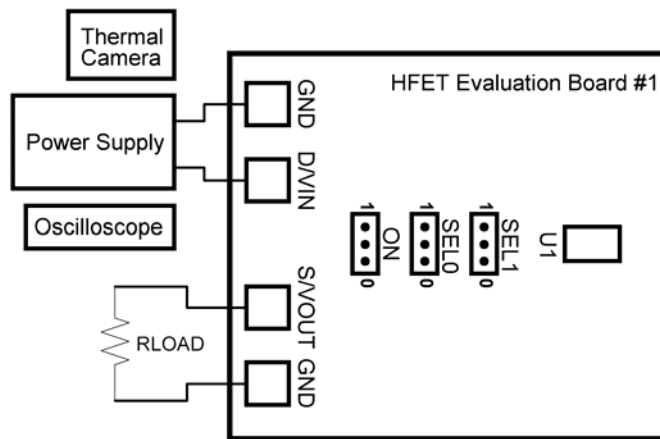


Figure 47. SLG59H1020V Evaluation Board Connection Circuit

EVB Configuration

1. Based on V_{IN} voltage, set SEL0, SEL1 to GND or 5 V to configure OVLO;
2. Connect oscilloscope probes to D/VIN, S/VOUT, ON, etc.;
3. Turn on Power Supply and set desired V_{IN} from 4.5 V...20 V range;
4. Toggle the ON signal High or Low to observe SLG59H1020V operation.

A 20 V, 50 mΩ, 3 A, Reverse Blocking Integrated Power Switch with V_{IN} Lockout Select and MOSFET Current Monitor Output

Package Top Marking System Definition



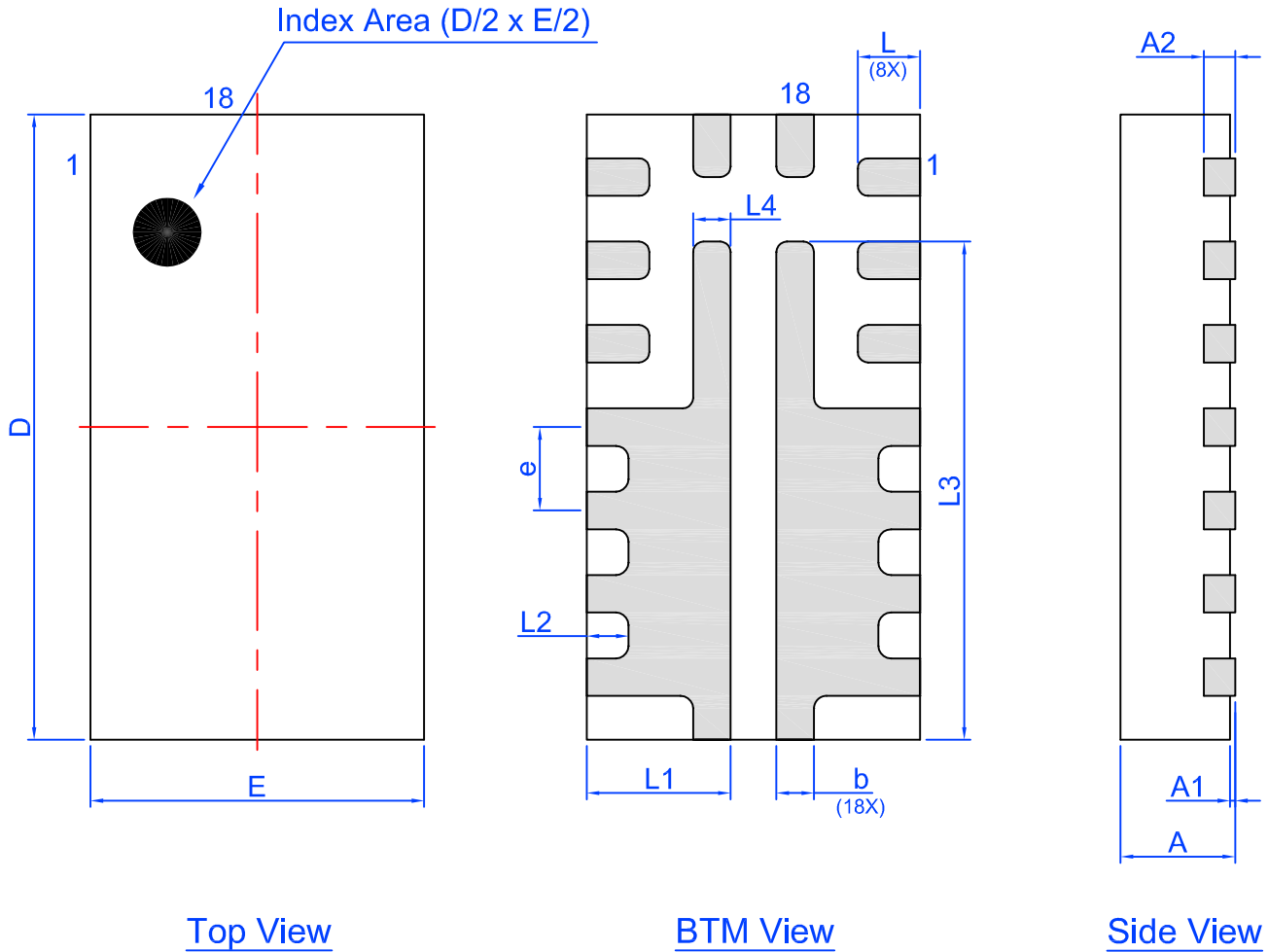
- 1020V - Part ID Field
- WW - Date Code Field¹
- NNN - Lot Traceability Code Field¹
- A - Assembly Site Code Field²
- RR - Part Revision Code Field²

Note 1: Each character in code field can be alphanumeric A-Z and 0-9
Note 2: Character in code field can be alphabetic A-Z

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Package Drawing and Dimensions

18 Lead TQFN Package 1.6 x 3 mm (Fused Lead)
JEDEC MO-220, Variation WCEE




Unit: mm

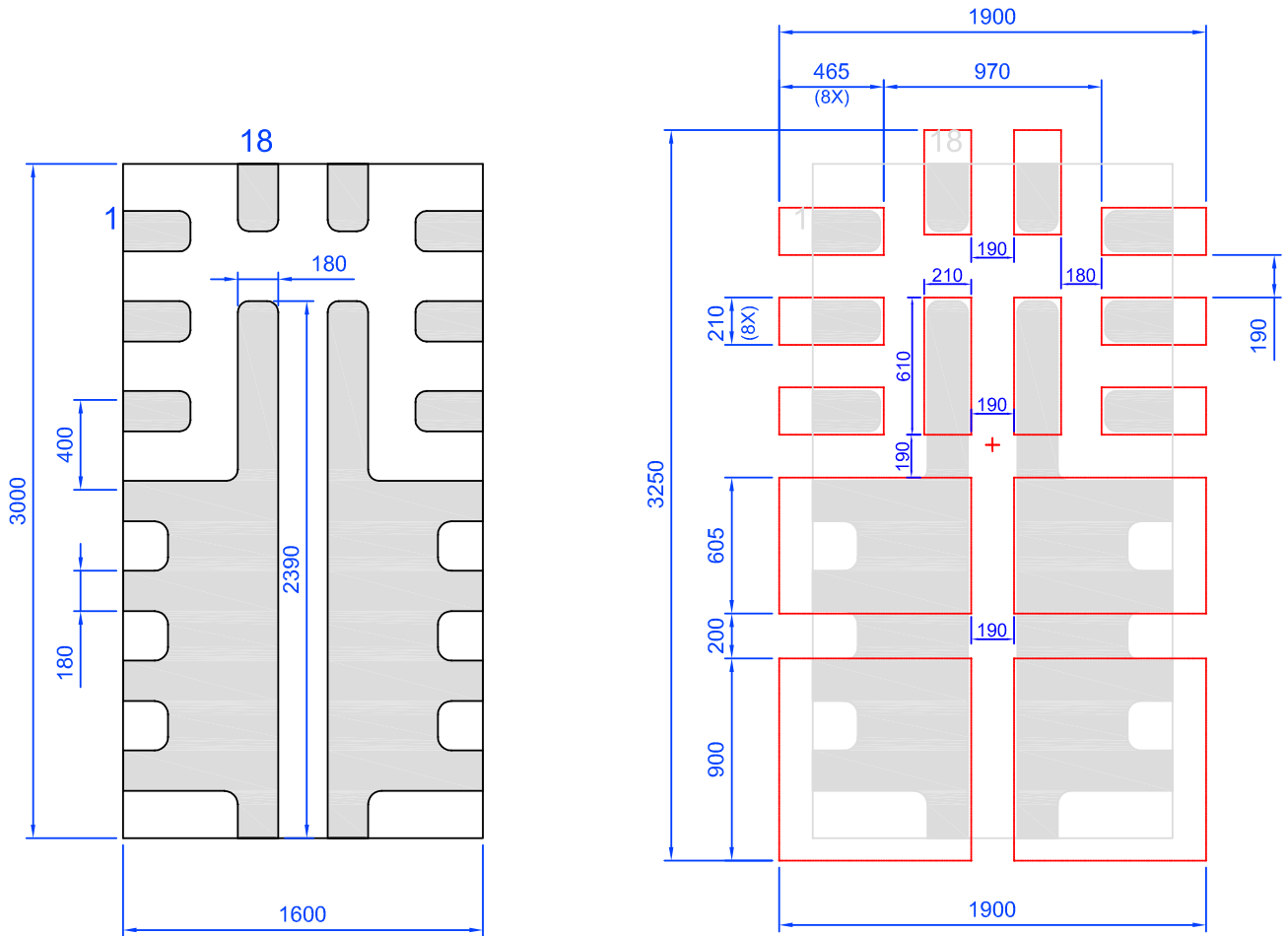
Symbol	Min	Nom.	Max	Symbol	Min	Nom.	Max
A	0.50	0.55	0.60	D	2.95	3.00	3.05
A1	0.005	-	0.05	E	1.55	1.60	1.65
A2	0.10	0.15	0.20	L	0.25	0.30	0.35
b	0.13	0.18	0.23	L1	0.64	0.69	0.74
e	0.40 BSC			L2	0.15	0.20	0.25
L3	2.34	2.39	2.44	L4	0.13	0.18	0.23

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SLG59H1020V 18-pin STQFN PCB Landing Pattern

 Exposed Pad
(PKG face down)

 Recommended Land Pattern
(PKG face down)



Note: All dimensions shown in micrometers (μm)

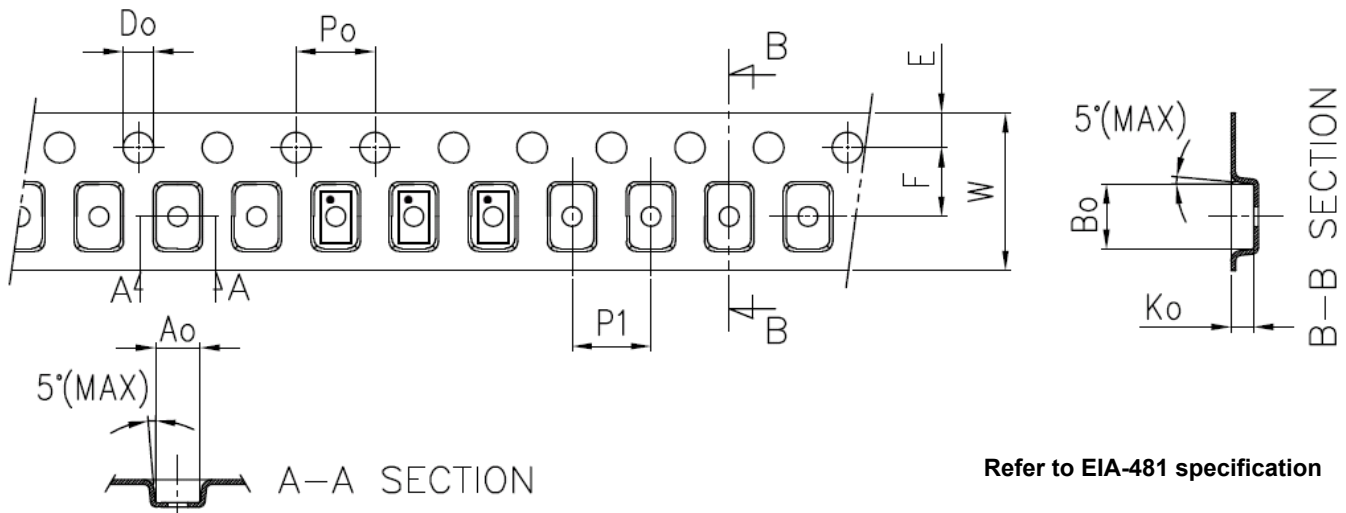
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Tape and Reel Specifications

Package Type	# of Pins	Nominal Package Size [mm]	Max Units		Reel & Hub Size [mm]	Leader (min)		Trailer (min)		Tape Width [mm]	Part Pitch [mm]
			per Reel	per Box		Pockets	Length [mm]	Pockets	Length [mm]		
STQFN 18L 1.6x3mm 0.4P FC Green	18	1.6 x 3 x 0.55	3,000	3,000	178 / 60	100	400	100	400	8	4

Carrier Tape Drawing and Dimensions

Package Type	Pocket BTM Length	Pocket BTM Width	Pocket Depth	Index Hole Pitch	Pocket Pitch	Index Hole Diameter	Index Hole to Tape Edge	Index Hole to Pocket Center	Tape Width
	A0	B0	K0	P0	P1	D0	E	F	W
STQFN 18L 1.6x3mm 0.4P FC Green	1.78	3.18	0.76	4	4	1.5	1.75	3.5	8



Recommended Reflow Soldering Profile

Please see IPC/JEDEC J-STD-020: latest revision for reflow profile based on package volume of 2.64 mm³ (nominal). More information can be found at www.jedec.org.

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Revision History

Date	Version	Change
12/20/2018	1.01	Updated style and formatting Updated Charts Added Layout Guidelines Fixed typos
10/19/2017	1.00	Production Release